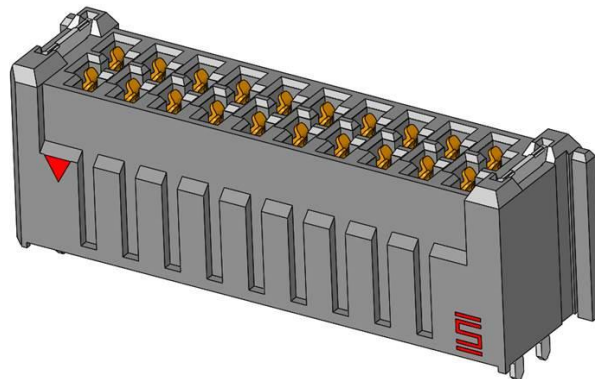
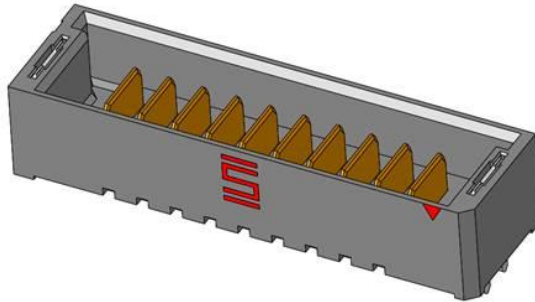




Project Number: Design Qualification Test Report	Tracking Code: 2476645_Report_Rev_2
Requested by: Roy Luo	Date: 5/31/2021
Part #: UMPS-XX-07.5-G-V-S-W-XR /UMPT-XX-XX.X-G-V-S-W-XR	
Part description: UMPS/UMPT	Tech: Kason He and Peter Chen
Test Start: 7/21/2020	Test Completed: 8/11/2020



DESIGN QUALIFICATION TEST REPORT

UMPS/UMPT

UMPS-XX-07.5-G-V-S-W-XR /UMPT-XX-XX.X-G-V-S-W-XR

Tracking Code:2476645_Report_Rev_2	Part #: UMPS-XX-07.5-G-V-S-W-XR /UMPT-XX-XX.X-G-V-S-W-XR
Part description: UMPS/UMPT	

REVISION HISTORY

DATA	REV.NUM.	DESCRIPTION	ENG
9/25/2020	1	Initial Issue	KH
5/31/2021	2	Update the part number	PC

CERTIFICATION

All instruments and measuring equipment were calibrated to National Institute for Standards and Technology (NIST) traceable standards according to ISO 10012-1 and ANSI/NCSL 2540-1, as applicable.

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SCOPE

To perform the following tests: Design Qualification test. Please see test plan.

APPLICABLE DOCUMENTS

Standards: EIA Publication 364

TEST SAMPLES AND PREPARATION

- 1) All materials were manufactured in accordance with the applicable product specification.
- 2) All test samples were identified and encoded to maintain traceability throughout the test sequences.
- 3) After soldering, the parts to be used for LLCR and DWV/IR testing were cleaned according to TLWI-0001.
- 4) Either an automated cleaning procedure or an ultrasonic cleaning procedure may be used.
- 5) The automated procedure is used with aqueous compatible soldering materials.
- 6) Parts not intended for testing LLCR and DWV/IR are visually inspected and cleaned if necessary.
- 7) Any additional preparation will be noted in the individual test sequences.
- 8) Solder Information: Lead free
- 9) Samtec Test PCBs used: PCB-110761-TST/PCB-110765-TST/PCB-110766-TST/PCB-110767-TST

FLOWCHARTS**Thermal Aging****Group 1**

UMPS-06-07.5-G-V-S-W-XR

UMPT-06-02.5-G-V-S-W-XR

8 Assemblies

Step	Description
1.	Contact Gaps
2.	Mating/Unmating Force ⁽²⁾
3.	LLCR ⁽¹⁾
4.	Thermal Age ⁽³⁾
5.	LLCR ⁽¹⁾ Max Delta = 1 mOhm
6.	Mating/Unmating Force ⁽²⁾
7.	Contact Gaps

(1) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

(2) Mating/Unmating Force = EIA-364-13

(3) Thermal Age = EIA-364-17

Test Condition = 4 (105°C)

Time Condition = B (250 Hours)

FLOWCHARTS Continued**Mating/Unmating/Durability**

<u>Group 1</u> UMPS-06-07.5-G-V-S-W-XR UMPT-06-02.5-G-V-S-W-XR 8 Assemblies		<u>Group 2</u> UMPS-10-07.5-G-V-S-W-XR UMPT-10-02.5-G-V-S-W-XR 8 Assemblies		<u>Group 3</u> UMPS-06-07.5-T-V-S-W-XR UMPT-06-02.5-T-V-S-W-XR 8 Assemblies		<u>Group 4</u> UMPS-10-07.5-T-V-S-W-XR UMPT-10-02.5-T-V-S-W-XR 8 Assemblies	
Step	Description	Step	Description	Step	Description	Step	Description
1.	Contact Gaps	1.	Contact Gaps	1.	Contact Gaps	1.	Contact Gaps
2.	LLCR (2)	2.	LLCR (2)	2.	LLCR (2)	2.	LLCR (2)
3.	Mating/Unmating Force (3)	3.	Mating/Unmating Force (3)	3.	Mating/Unmating Force (3)	3.	Mating/Unmating Force (3)
4.	Cycles Quantity ■ 25 Cycles	4.	Cycles Quantity ■ 25 Cycles	4.	Cycles Quantity ■ 25 Cycles	4.	Cycles Quantity ■ 25 Cycles
5.	Mating/Unmating Force (3)	5.	Mating/Unmating Force (3)	5.	Mating/Unmating Force (3)	5.	Mating/Unmating Force (3)
6.	Cycles Quantity ■ 25 Cycles	6.	Cycles Quantity ■ 25 Cycles	6.	Cycles Quantity ■ 25 Cycles	6.	Cycles Quantity ■ 25 Cycles
7.	Mating/Unmating Force (3)	7.	Mating/Unmating Force (3)	7.	Mating/Unmating Force (3)	7.	Mating/Unmating Force (3)
8.	Cycles Quantity ■ 25 Cycles	8.	Cycles Quantity ■ 25 Cycles	8.	Cycles Quantity ■ 25 Cycles	8.	Cycles Quantity ■ 25 Cycles
9.	Mating/Unmating Force (3)	9.	Mating/Unmating Force (3)	9.	Mating/Unmating Force (3)	9.	Mating/Unmating Force (3)
10.	Cycles Quantity ■ 25 Cycles	10.	Cycles Quantity ■ 25 Cycles	10.	Cycles Quantity ■ 25 Cycles	10.	Cycles Quantity ■ 25 Cycles
11.	Mating/Unmating Force (3)	11.	Mating/Unmating Force (3)	11.	Mating/Unmating Force (3)	11.	Mating/Unmating Force (3)
12.	Contact Gaps	12.	Contact Gaps	12.	Contact Gaps	12.	Contact Gaps
13.	LLCR (2) Max Delta ■ 1 mOhm	13.	LLCR (2) Max Delta ■ 1 mOhm	13.	LLCR (2) Max Delta ■ 1 mOhm	13.	LLCR (2) Max Delta ■ 1 mOhm
14.	Thermal Shock (4)	14.	Thermal Shock (4)	14.	Thermal Shock (4)	14.	Thermal Shock (4)
15.	LLCR (2) Max Delta ■ 1 mOhm	15.	LLCR (2) Max Delta ■ 1 mOhm	15.	LLCR (2) Max Delta ■ 1 mOhm	15.	LLCR (2) Max Delta ■ 1 mOhm
16.	Humidity (1)	16.	Humidity (1)	16.	Humidity (1)	16.	Humidity (1)
17.	LLCR (2) Max Delta ■ 1 mOhm	17.	LLCR (2) Max Delta ■ 1 mOhm	17.	LLCR (2) Max Delta ■ 1 mOhm	17.	LLCR (2) Max Delta ■ 1 mOhm
18.	Mating/Unmating Force (3)	18.	Mating/Unmating Force (3)	18.	Mating/Unmating Force (3)	18.	Mating/Unmating Force (3)

(1) Humidity = EIA-364-31

Test Condition = B (240 Hours)

Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)

Test Exceptions: ambient pre-condition and delete steps 7a and 7b

(2) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

(3) Mating/Unmating Force = EIA-364-13

(4) Thermal Shock = EIA-364-32

Exposure Time at Temperature Extremes = 1/2 Hour

Method A, Test Condition = I (-55°C to +85°C)

Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued**IR/DWV****Pin-to-Pin**

<u>Group 1</u> UMPS-10-07.5-G-V-S-W-XR UMPT-10-07.5-G-V-S-W-XR 2 Assemblies		<u>Group 2</u> UMPS-10-07.5-G-V-S-W-XR 2 Assemblies		<u>Group 3</u> UMPT-10-07.5-G-V-S-W-XR 2 Assemblies		<u>Group 4</u> UMPS-10-07.5-G-V-S-W-XR UMPT-10-07.5-G-V-S-W-XR 2 Assemblies	
Step	Description	Step	Description	Step	Description	Step	Description
1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	IR (4)
						2.	DWV at Test Voltage (1)
						3.	Thermal Shock (5)
						4.	IR (4)
						5.	DWV at Test Voltage (1)
						6.	Humidity (3)
						7.	IR (4)
						8.	DWV at Test Voltage (1)

Pin-to-Closest Metallic Hardware

<u>Group 5</u> UMPS-10-07.5-G-V-S-W-XR UMPT-10-07.5-G-V-S-W-XR 2 Assemblies		<u>Group 6</u> UMPS-10-07.5-G-V-S-W-XR 2 Assemblies		<u>Group 7</u> UMPT-10-07.5-G-V-S-W-XR 2 Assemblies		<u>Group 8</u> UMPS-10-07.5-G-V-S-W-XR UMPT-10-07.5-G-V-S-W-XR 2 Assemblies	
Step	Description	Step	Description	Step	Description	Step	Description
1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	IR (4)
						2.	DWV at Test Voltage (1)
						3.	Thermal Shock (5)
						4.	IR (4)
						5.	DWV at Test Voltage (1)
						6.	Humidity (3)
						7.	IR (4)
						8.	DWV at Test Voltage (1)

(1) DWV at Test Voltage = EIA-364-20

Test Condition = 1 (Sea Level)

DWV test voltage is equal to 75% of the lowest breakdown voltage

Test voltage applied for 60 seconds

(2) DWV Breakdown = EIA-364-20

Test Condition = 1 (Sea Level)

DWV test voltage is equal to 75% of the lowest breakdown voltage

Test voltage applied for 60 seconds

(3) Humidity = EIA-364-31

Test Condition = B (240 Hours)

Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)

Test Exceptions: ambient pre-condition and delete steps 7a and 7b

(4) IR = EIA-364-21

Test Condition = 500 Vdc, 2 Minutes Max

(5) Thermal Shock = EIA-364-32

Exposure Time at Temperature Extremes = 1/2 Hour

Method A, Test Condition = I (-55°C to +85°C)

Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued**Current Carrying Capacity**Group 1

UMPS-10-07.5-G-V-S-W-XR

UMPT-10-12.5-G-V-S-W-XR

1 Pins Powered

Power

Step	Description
1.	CCC (1) Rows ■ 1 Number of Positions ■ 1

Group 2

UMPS-10-07.5-G-V-S-W-XR

UMPT-10-12.5-G-V-S-W-XR

2 Pins Powered

Power

Step	Description
1.	CCC (1) Rows ■ 1 Number of Positions ■ 2

Group 3

UMPS-10-07.5-G-V-S-W-XR

UMPT-10-12.5-G-V-S-W-XR

3 Pins Powered

Power

Step	Description
1.	CCC (1) Rows ■ 1 Number of Positions ■ 3

Group 4

UMPS-10-07.5-G-V-S-W-XR

UMPT-10-12.5-G-V-S-W-XR

4 Pins Powered

Power

Step	Description
1.	CCC (1) Rows ■ 1 Number of Positions ■ 4

Group 5

UMPS-10-07.5-G-V-S-W-XR

UMPT-10-12.5-G-V-S-W-XR

10 Pins Powered

Power

Step	Description
1.	CCC (1) Rows ■ 1 Number of Positions ■ 10

Group 6

UMPS-10-07.5-T-V-S-W-XR

UMPT-10-12.5-T-V-S-W-XR

1 Pins Powered

Power

Step	Description
1.	CCC (1) Rows ■ 1 Number of Positions ■ 1

Group 7

UMPS-10-07.5-T-V-S-W-XR

UMPT-10-12.5-T-V-S-W-XR

2 Pins Powered

Power

Step	Description
1.	CCC (1) Rows ■ 1 Number of Positions ■ 2

Group 8

UMPS-10-07.5-T-V-S-W-XR

UMPT-10-12.5-T-V-S-W-XR

3 Pins Powered

Power

Step	Description
1.	CCC (1) Rows ■ 1 Number of Positions ■ 3

Group 9

UMPS-10-07.5-T-V-S-W-XR

UMPT-10-12.5-T-V-S-W-XR

4 Pins Powered

Power

Step	Description
1.	CCC (1) Rows ■ 1 Number of Positions ■ 4

Group 10

UMPS-10-07.5-T-V-S-W-XR

UMPT-10-12.5-T-V-S-W-XR

10 Pins Powered

Power

Step	Description
1.	CCC (1) Rows ■ 1 Number of Positions ■ 10

(1) CCC = EIA-364-70

Method 2, Temperature Rise Versus Current Curve

(TIN PLATING) - Tabulate calculated current at RT, 65°C, 75°C and 95°C after derating 20% and based on 105°C

(GOLD PLATING) - Tabulate calculated current at RT, 85°C, 95°C and 115°C after derating 20% and based on 125°C

FLOWCHARTS Continued**Mechanical Shock/Random Vibration/Event Detection**Group 1

UMPS-10-07.5-G-V-S-W-XR

UMPT-10-12.5-G-V-S-W-XR

60 Points

Step	Description
1.	Nanosecond Event Detection (Mechanical Shock) ⁽¹⁾
2.	Nanosecond Event Detection (Random Vibration) ⁽²⁾

(1) Nanosecond Event Detection (Mechanical Shock)

Use EIA-364-87 for Nanosecond Event Detection:

Test Condition = F (50 nanoseconds at 10 ohms)

Use EIA-364-27 for Mechanical Shock:

Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)

Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(2) Nanosecond Event Detection (Random Vibration)

Use EIA-364-87 for Nanosecond Event Detection:

Test Condition = F (50 nanoseconds at 10 ohms)

Use EIA-364-28 for Random Vibration:

Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

THERMAL:

- 1) EIA-364-17, *Temperature Life with or without Electrical Load Test Procedure for Electrical Connectors*.
- 2) Test Condition 4 at 105° C
- 3) Test Time Condition B for 250 hours.
- 4) All test samples are pre-conditioned at ambient.
- 5) All test samples are exposed to environmental stressing in the mated condition.

THERMAL SHOCK:

- 1) EIA-364-32, *Thermal Shock (Temperature Cycling) Test Procedure for Electrical Connectors*.
- 2) Test Condition 1: -55°C to +85°C
- 3) Test Time: ½ hour dwell at each temperature extreme
- 4) Number of Cycles: 100
- 5) All test samples are pre-conditioned at ambient.
- 6) All test samples are exposed to environmental stressing in the mated condition.

HUMIDITY:

- 1) Reference document: EIA-364-31, *Humidity Test Procedure for Electrical Connectors*.
- 2) Test Condition B, 240 Hours.
- 3) Method III, +25° C to + 65° C, 90% to 98% Relative Humidity excluding sub-cycles 7a and 7b.
- 4) All samples are pre-conditioned at ambient.
- 5) All test samples are exposed to environmental stressing in the mated condition.

MATING/UNMATING:

- 1) Reference document: EIA-364-13, *Mating and Unmating Forces Test Procedure for Electrical Connectors*.
- 2) The full insertion position was to within 0.003” to 0.004” of the plug bottoming out in the receptacle to prevent damage to the system under test.
- 3) One of the mating parts is secured to a floating X-Y table to prevent damage during cycling.

MECHANICAL SHOCK (Specified Pulse):

- 1) Reference document: EIA-364-27, *Mechanical Shock Test Procedure for Electrical Connectors*
- 2) Test Condition C
- 3) Peak Value: 100 G
- 4) Duration: 6 Milliseconds
- 5) Wave Form: Half Sine
- 6) Velocity: 12.3 ft/s
- 7) Number of Shocks: 3 Shocks / Direction, 3 Axis (18 Total)

VIBRATION:

- 1) Reference document: EIA-364-28, *Vibration Test Procedure for Electrical Connectors*
- 2) Test Condition V, Letter B
- 3) Power Spectral Density: 0.04 G² / Hz
- 4) G ‘RMS’: 7.56
- 5) Frequency: 50 to 2000 Hz
- 6) Duration: 2.0 Hours per axis (3 axis total)

NANOSECOND-EVENT DETECTION:

- 1) Reference document: EIA-364-87, *Nanosecond-Event Detection for Electrical Connectors*
- 2) Prior to test, the samples were characterized to assure the low nanosecond event being monitored will trigger the detector.
- 3) After characterization it was determined the test samples could be monitored for 50 nanosecond events

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

TEMPERATURE RISE (Current Carrying Capacity, CCC):

- 1) EIA-364-70, *Temperature Rise versus Current Test Procedure for Electrical Connectors and Sockets*.
- 2) When current passes through a contact, the temperature of the contact increases as a result of I^2R (resistive) heating.
- 3) The number of contacts being investigated plays a significant part in power dissipation and therefore temperature rise.
- 4) The size of the temperature probe can affect the measured temperature.
- 5) Copper traces on PC boards will contribute to temperature rise:
 - a. Self-heating (resistive)
 - b. Reduction in heat sink capacity affecting the heated contacts
- 6) A de-rating curve, usually 20%, is calculated.
- 7) Calculated de-rated currents at four temperature points are reported:
 - a. Ambient
 - b. 85° C
 - c. 95° C
 - d. 115° C
- 8) Typically, neighboring contacts (in close proximity to maximize heat buildup) are energized.
- 9) The thermocouple (or temperature measuring probe) will be positioned at a location to sense the maximum temperature in the vicinity of the heat generation area.
- 10) A computer program, *TR 803.exe*, ensures accurate stability for data acquisition.
- 11) Hook-up wire cross section is larger than the cross section of any connector leads/PC board traces, jumpers, etc.
- 12) Hook-up wire length is longer than the minimum specified in the referencing standard.

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

LLCR:

- 1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
 - a. $\leq +0.33$ mOhms: -----Stable
 - b. $+0.34$ to $+0.66$ mOhms: -----Minor
 - c. $+0.67$ to $+1.0$ mOhms: -----Acceptable
 - d. $+1.01$ to $+50.0$ mOhms: -----Marginal
 - e. $+50.1$ to $+1000$ mOhms: -----Unstable
 - f. $>+1000$ mOhms: -----Open Failure

INSULATION RESISTANCE (IR):

To determine the resistance of insulation materials to leakage of current through or on the surface of these materials when a DC potential is applied.

- 1) PROCEDURE:
 - a. Reference document: EIA-364-21, *Insulation Resistance Test Procedure for Electrical Connectors*.
 - b. Test Conditions:
 - i. Between Adjacent Contacts or Signal-to-Ground
 - ii. Electrification Time 2.0 minutes
 - iii. Test Voltage (500 VDC) corresponds to calibration settings for measuring resistances.
- 2) MEASUREMENTS:
- 3) When the specified test voltage is applied (VDC), the insulation resistance shall not be less than 5000 megohms.

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

To determine if the sockets can operate at its rated voltage and withstand momentary over potentials due to switching, surges, and other similar phenomenon. Separate samples are used to evaluate the effect of environmental stresses so not to influence the readings from arcing that occurs during the measurement process.

- 1) PROCEDURE:
 - a. Reference document: EIA-364-20, *Withstanding Voltage Test Procedure for Electrical Connectors*.
 - b. Test Conditions:
 - i. Between Adjacent Contacts or Signal-to-Ground
 - ii. Barometric Test Condition 1
 - iii. Rate of Application 500 V/Sec
 - iv. Test Voltage (VAC) until breakdown occurs
- 2) MEASUREMENTS/CALCULATIONS
 - a. The breakdown voltage shall be measured and recorded.
 - b. The dielectric withstanding voltage shall be recorded as 75% of the minimum breakdown voltage.
 - c. The working voltage shall be recorded as one-third (1/3) of the dielectric withstanding voltage (one-fourth of the breakdown voltage).

RESULTS

Temperature Rise, CCC at a 20% de-rating

UMPS-10-07.5-G-V-S-W-XR /UMPT-10-12.5-G-V-S-W-XR

- CCC for a 30°C Temperature Rise-----16.8A per contact with 1 contact (1x1) powered
- CCC for a 30°C Temperature Rise-----14.0 A per contact with 2 contacts (1x2) powered
- CCC for a 30°C Temperature Rise-----12.4 A per contact with 3 contacts (1x3) powered
- CCC for a 30°C Temperature Rise-----12.1 A per contact with 4 contacts (1x4) powered
- CCC for a 30°C Temperature Rise-----8.9 A per contact with 10 contacts (1x10) powered

UMPS-10-07.5-T-V-S-W-XR/UMPT-10-12.5-T-V-S-W-XR

- CCC for a 30°C Temperature Rise-----17.8 A per contact with 1 contact (1x1) powered
- CCC for a 30°C Temperature Rise-----15.5 A per contact with 2 contacts (1x2) powered
- CCC for a 30°C Temperature Rise-----13.2 A per contact with 3 contacts (1x3) powered
- CCC for a 30°C Temperature Rise-----12.7 A per contact with 4 contacts (1x4) powered
- CCC for a 30°C Temperature Rise-----9.6 A per contact with 10 contacts (1x10) powered

Mating – Unmating Forces

Thermal Aging Group (UMPS-06-07.5-G-V-S-W-XR /UMPT-06-02.5-G-V-S-W-XR)

- Initial
 - Mating
 - Min ----- 6.14 Lbs
 - Max----- 7.69 Lbs
 - Unmating
 - Min ----- 2.90 Lbs
 - Max----- 5.07 Lbs
- After Thermal
 - Mating
 - Min ----- 2.57 Lbs
 - Max----- 3.81 Lbs
 - Unmating
 - Min ----- 1.67 Lbs
 - Max----- 2.42 Lbs

RESULTS Continued**Mating-Unmating Durability Group 1 (UMPS-06-07.5-G-V-S-W-XR/UMPT-06-02.5-G-V-S-W-XR)**

- **Initial**
 - **Mating**
 - **Min** ----- 5.59 Lbs
 - **Max** ----- 6.76 Lbs
 - **Unmating**
 - **Min** ----- 3.03 Lbs
 - **Max** ----- 4.23 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min** ----- 5.91 Lbs
 - **Max** ----- 6.43 Lbs
 - **Unmating**
 - **Min** ----- 3.99 Lbs
 - **Max** ----- 5.27 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min** ----- 5.95 Lbs
 - **Max** ----- 6.38 Lbs
 - **Unmating**
 - **Min** ----- 4.89 Lbs
 - **Max** ----- 5.70 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min** ----- 6.03 Lbs
 - **Max** ----- 6.43 Lbs
 - **Unmating**
 - **Min** ----- 5.29 Lbs
 - **Max** ----- 6.07 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min** ----- 5.81 Lbs
 - **Max** ----- 6.53 Lbs
 - **Unmating**
 - **Min** ----- 4.94 Lbs
 - **Max** ----- 6.30 Lbs
- **Humidity**
 - **Mating**
 - **Min** ----- 2.81 Lbs
 - **Max** ----- 3.23 Lbs
 - **Unmating**
 - **Min** ----- 2.01 Lbs
 - **Max** ----- 2.34 Lbs

RESULTS Continued**Mating-Unmating Durability Group 2 (UMPS-10-07.5-G-V-S-W-XR/UMPT-10-02.5-G-V-S-W-XR)**

- **Initial**
 - **Mating**
 - **Min -----10.49 Lbs**
 - **Max-----14.14 Lbs**
 - **Unmating**
 - **Min ----- 5.11 Lbs**
 - **Max----- 8.75 Lbs**
- **After 25 Cycles**
 - **Mating**
 - **Min -----12.34 Lbs**
 - **Max-----16.18 Lbs**
 - **Unmating**
 - **Min ----- 7.05 Lbs**
 - **Max----- 9.71 Lbs**
- **After 50 Cycles**
 - **Mating**
 - **Min -----14.44 Lbs**
 - **Max-----19.18 Lbs**
 - **Unmating**
 - **Min ----- 7.42 Lbs**
 - **Max-----11.08 Lbs**
- **After 75 Cycles**
 - **Mating**
 - **Min -----17.21 Lbs**
 - **Max-----19.50 Lbs**
 - **Unmating**
 - **Min ----- 8.31 Lbs**
 - **Max-----11.76 Lbs**
- **After 100 Cycles**
 - **Mating**
 - **Min -----17.03 Lbs**
 - **Max-----20.31 Lbs**
 - **Unmating**
 - **Min ----- 9.21 Lbs**
 - **Max-----11.16 Lbs**
- **Humidity**
 - **Mating**
 - **Min ----- 4.87 Lbs**
 - **Max----- 5.33 Lbs**
 - **Unmating**
 - **Min ----- 2.53 Lbs**
 - **Max----- 3.67 Lbs**

RESULTS Continued**Mating-Unmating Durability Group 3 (UMPS-06-07.5-T-V-S-W-XR/UMPT-06-02.5-T-V-S-W-XR)**

- **Initial**
 - **Mating**
 - **Min** ----- 7.21 Lbs
 - **Max** ----- 9.65 Lbs
 - **Unmating**
 - **Min** ----- 6.22 Lbs
 - **Max** ----- 8.82 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min** ----- 7.29 Lbs
 - **Max** ----- 8.34 Lbs
 - **Unmating**
 - **Min** ----- 5.49 Lbs
 - **Max** ----- 6.85 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min** ----- 7.55 Lbs
 - **Max** ----- 8.50 Lbs
 - **Unmating**
 - **Min** ----- 5.51 Lbs
 - **Max** ----- 6.90 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min** ----- 8.05 Lbs
 - **Max** ----- 9.10 Lbs
 - **Unmating**
 - **Min** ----- 5.40 Lbs
 - **Max** ----- 6.76 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min** ----- 8.08 Lbs
 - **Max** ----- 9.49 Lbs
 - **Unmating**
 - **Min** ----- 5.41 Lbs
 - **Max** ----- 6.99 Lbs
- **Humidity**
 - **Mating**
 - **Min** ----- 2.85 Lbs
 - **Max** ----- 3.74 Lbs
 - **Unmating**
 - **Min** ----- 2.47 Lbs
 - **Max** ----- 2.68 Lbs

RESULTS Continued**Mating-Unmating Durability Group 4 (UMPS-10-07.5-T-V-S-W-XR/UMPT-10-02.5-T-V-S-W-XR)**

- **Initial**
 - **Mating**
 - **Min** -----13.69 Lbs
 - **Max** -----16.80 Lbs
 - **Unmating**
 - **Min** -----12.35 Lbs
 - **Max** -----14.64 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min** -----13.15 Lbs
 - **Max** -----14.97 Lbs
 - **Unmating**
 - **Min** ----- 9.39 Lbs
 - **Max** -----11.67 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min** -----12.32 Lbs
 - **Max** -----13.84 Lbs
 - **Unmating**
 - **Min** ----- 9.39 Lbs
 - **Max** -----10.23 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min** -----12.59 Lbs
 - **Max** -----13.78 Lbs
 - **Unmating**
 - **Min** ----- 9.65 Lbs
 - **Max** -----10.14 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min** -----13.17 Lbs
 - **Max** -----14.07 Lbs
 - **Unmating**
 - **Min** ----- 9.82 Lbs
 - **Max** -----10.61 Lbs
- **Humidity**
 - **Mating**
 - **Min** ----- 5.49 Lbs
 - **Max** ----- 6.52 Lbs
 - **Unmating**
 - **Min** ----- 4.64 Lbs
 - **Max** ----- 5.15 Lbs

RESULTS Continued**Insulation Resistance minimums, IR****Pin to Pin**

- **Initial**
 - Mated -----45000 Meg Ω ----- Passed
 - Unmated -----45000 Meg Ω ----- Passed
- **Thermal Shock**
 - Mated -----45000 Meg Ω ----- Passed
 - Unmated -----45000Meg Ω ----- Passed
- **Humidity**
 - Mated -----45000 Meg Ω ----- Passed
 - Unmated -----45000 Meg Ω ----- Passed

Pin to Closest Metallic Hardware

- **Initial**
 - Mated -----45000 Meg Ω ----- Passed
 - Unmated -----45000 Meg Ω ----- Passed
- **Thermal Shock**
 - Mated -----45000 Meg Ω ----- Passed
 - Unmated -----45000Meg Ω ----- Passed
- **Humidity**
 - Mated -----45000 Meg Ω ----- Passed
 - Unmated -----45000 Meg Ω ----- Passed

Dielectric Withstanding Voltage minimums, DWV

- **Minimums**
 - Breakdown Voltage ----- 1685 VAC
 - Test Voltage ----- 1265 VAC
 - Working Voltage -----420 VAC

Pin to Pin

- **Initial DWV** -----Passed
- **Thermal DWV** -----Passed
- **Humidity DWV** -----Passed

Pin to Closest Metallic Hardware

- **Initial DWV** -----Passed
- **Thermal DWV** -----Passed
- **Humidity DWV** -----Passed

RESULTS Continued**LLCR Thermal Aging Group (48 LLCR test points)****UMPS-06-07.5-G-V-S-W-XR/UMPT-06-02.5-G-V-S-W-XR**

- **Initial** -----1.05 mOhms Max
- **Thermal**
 - <= +0.33 mOhms ----- 47 Points ----- Stable
 - +0.34 to +0.66 mOhms ----- 1 Points ----- Minor
 - +0.67 to +1.0 mOhms ----- 0 Points ----- Acceptable
 - +1.01 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +1000 mOhms ----- 0 Points ----- Unstable
 - >+1000 mOhms ----- 0 Points ----- Open Failure

LLCR Mating/Unmating Durability Group (48 LLCR test points)**Group 1 (UMPS-06-07.5-G-V-S-W-XR/UMPT-06-02.5-G-V-S-W-XR)**

- **Initial** -----1.05 mOhms Max
- **Durability, 100 Cycles**
 - <= +0.33 mOhms ----- 48 Points ----- Stable
 - +0.34 to +0.66 mOhms ----- 0 Points ----- Minor
 - +0.67 to +1.0 mOhms ----- 0 Points ----- Acceptable
 - +1.01 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +1000 mOhms ----- 0 Points ----- Unstable
 - >+1000 mOhms ----- 0 Points ----- Open Failure
- **Thermal Shock**
 - <= +0.33 mOhms ----- 48 Points ----- Stable
 - +0.34 to +0.66 mOhms ----- 0 Points ----- Minor
 - +0.67 to +1.0 mOhms ----- 0 Points ----- Acceptable
 - +1.01 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +1000 mOhms ----- 0 Points ----- Unstable
 - >+1000 mOhms ----- 0 Points ----- Open Failure
- **Humidity**
 - <= +0.33 mOhms ----- 38 Points ----- Stable
 - +0.34 to +0.66 mOhms ----- 7 Points ----- Minor
 - +0.67 to +1.0 mOhms ----- 3 Points ----- Acceptable
 - +1.01 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +1000 mOhms ----- 0 Points ----- Unstable
 - >+1000 mOhms ----- 0 Points ----- Open Failure

RESULTS Continued**LLCR Mating/Unmating Durability Group (80 LLCR test points)****Group 2 (UMPS-10-07.5-G-V-S-W-XR/UMPT-10-02.5-G-V-S-W-XR)**

- Initial -----0.97 mOhms Max
- Durability, 100 Cycles
 - <= +0.33 mOhms ----- 80 Points ----- Stable
 - +0.34 to +0.66 mOhms ----- 0 Points ----- Minor
 - +0.67 to +1.0 mOhms ----- 0 Points ----- Acceptable
 - +1.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +1000 mOhms ----- 0 Points ----- Unstable
 - >+1000 mOhms ----- 0 Points ----- Open Failure
- Thermal Shock
 - <= +0.33 mOhms ----- 80 Points ----- Stable
 - +0.34 to +0.66 mOhms ----- 0 Points ----- Minor
 - +0.67 to +1.0 mOhms ----- 0 Points ----- Acceptable
 - +1.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +1000 mOhms ----- 0 Points ----- Unstable
 - >+1000 mOhms ----- 0 Points ----- Open Failure
- Humidity
 - <= +0.33 mOhms ----- 53 Points ----- Stable
 - +0.34 to +0.66 mOhms ----- 20 Points ----- Minor
 - +0.67 to +1.0 mOhms ----- 4 Points ----- Acceptable
 - +1.1 to +50.0 mOhms ----- 3 Points ----- Marginal
 - +50.1 to +1000 mOhms ----- 0 Points ----- Unstable
 - >+1000 mOhms ----- 0 Points ----- Open Failure

LLCR Mating/Unmating Durability Group (48 LLCR test points)**Group 3 (UMPS-06-07.5-T-V-S-W-XR/UMPT-06-02.5-T-V-S-W-XR)**

- Initial -----0.99 mOhms Max
- Durability, 100 Cycles
 - <= +0.33 mOhms ----- 42 Points ----- Stable
 - +0.34 to +0.66 mOhms ----- 6 Points ----- Minor
 - +0.67 to +1.0 mOhms ----- 0 Points ----- Acceptable
 - +1.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +1000 mOhms ----- 0 Points ----- Unstable
 - >+1000 mOhms ----- 0 Points ----- Open Failure
- Thermal Shock
 - <= +0.33 mOhms ----- 36 Points ----- Stable
 - +0.34 to +0.66 mOhms ----- 12 Points ----- Minor
 - +0.67 to +1.0 mOhms ----- 0 Points ----- Acceptable
 - +1.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +1000 mOhms ----- 0 Points ----- Unstable
 - >+1000 mOhms ----- 0 Points ----- Open Failure
- Humidity
 - <= +0.33 mOhms ----- 7 Points ----- Stable
 - +0.34 to +0.66 mOhms ----- 19 Points ----- Minor
 - +0.67 to +1.0 mOhms ----- 19 Points ----- Acceptable
 - +1.1 to +50.0 mOhms ----- 3 Points ----- Marginal
 - +50.1 to +1000 mOhms ----- 0 Points ----- Unstable
 - >+1000 mOhms ----- 0 Points ----- Open Failure

RESULTS Continued**LLCR Mating/Unmating Durability Group (80 LLCR test points)****Group 4 (UMPS-10-07.5-T-V-S-W-XR/UMPT-10-02.5-T-V-S-W-XR)**

- **Initial -----0.90 mOhms Max**
- **Durability, 100 Cycles**
 - **<= +0.33 mOhms ----- 77 Points ----- Stable**
 - **+0.34 to +0.66 mOhms ----- 3 Points ----- Minor**
 - **+0.67 to +1.0 mOhms ----- 0 Points ----- Acceptable**
 - **+1.1 to +50.0 mOhms ----- 0 Points ----- Marginal**
 - **+50.1 to +1000 mOhms ----- 0 Points ----- Unstable**
 - **>+1000 mOhms ----- 0 Points ----- Open Failure**
- **Thermal Shock**
 - **<= +0.33 mOhms ----- 48 Points ----- Stable**
 - **+0.34 to +0.66 mOhms ----- 25 Points ----- Minor**
 - **+0.67 to +1.0 mOhms ----- 7 Points ----- Acceptable**
 - **+1.1 to +50.0 mOhms ----- 0 Points ----- Marginal**
 - **+50.1 to +1000 mOhms ----- 0 Points ----- Unstable**
 - **>+1000 mOhms ----- 0 Points ----- Open Failure**
- **Humidity**
 - **<= +0.33 mOhms ----- 34 Points ----- Stable**
 - **+0.34 to +0.66 mOhms ----- 28 Points ----- Minor**
 - **+0.67 to +1.0 mOhms ----- 16 Points ----- Acceptable**
 - **+1.1 to +50.0 mOhms ----- 2 Points ----- Marginal**
 - **+50.1 to +1000 mOhms ----- 0 Points ----- Unstable**
 - **>+1000 mOhms ----- 0 Points ----- Open Failure**

Mechanical Shock & Random Vibration:

- **Shock**
 - **No Damage ----- Pass**
 - **50 Nanoseconds ----- Pass**
- **Vibration**
 - **No Damage ----- Pass**
 - **50 Nanoseconds ----- Pass**

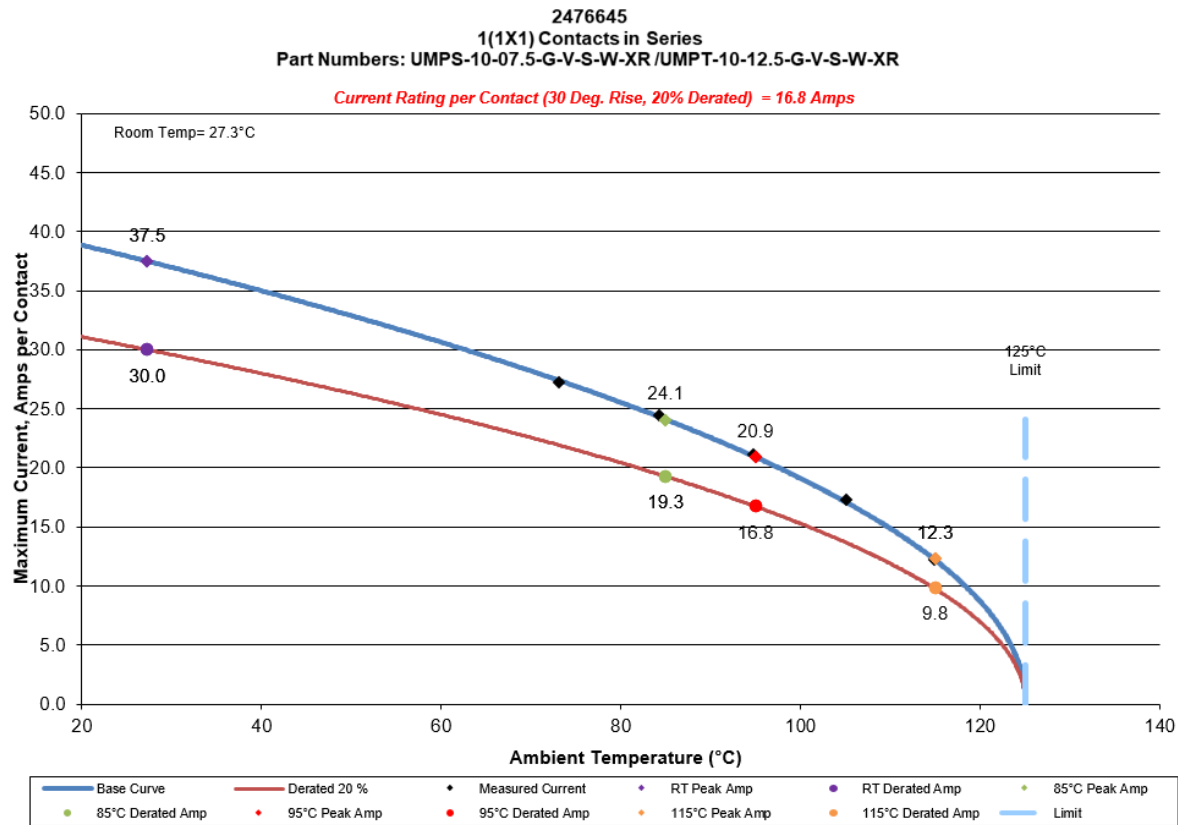
DATA SUMMARIES

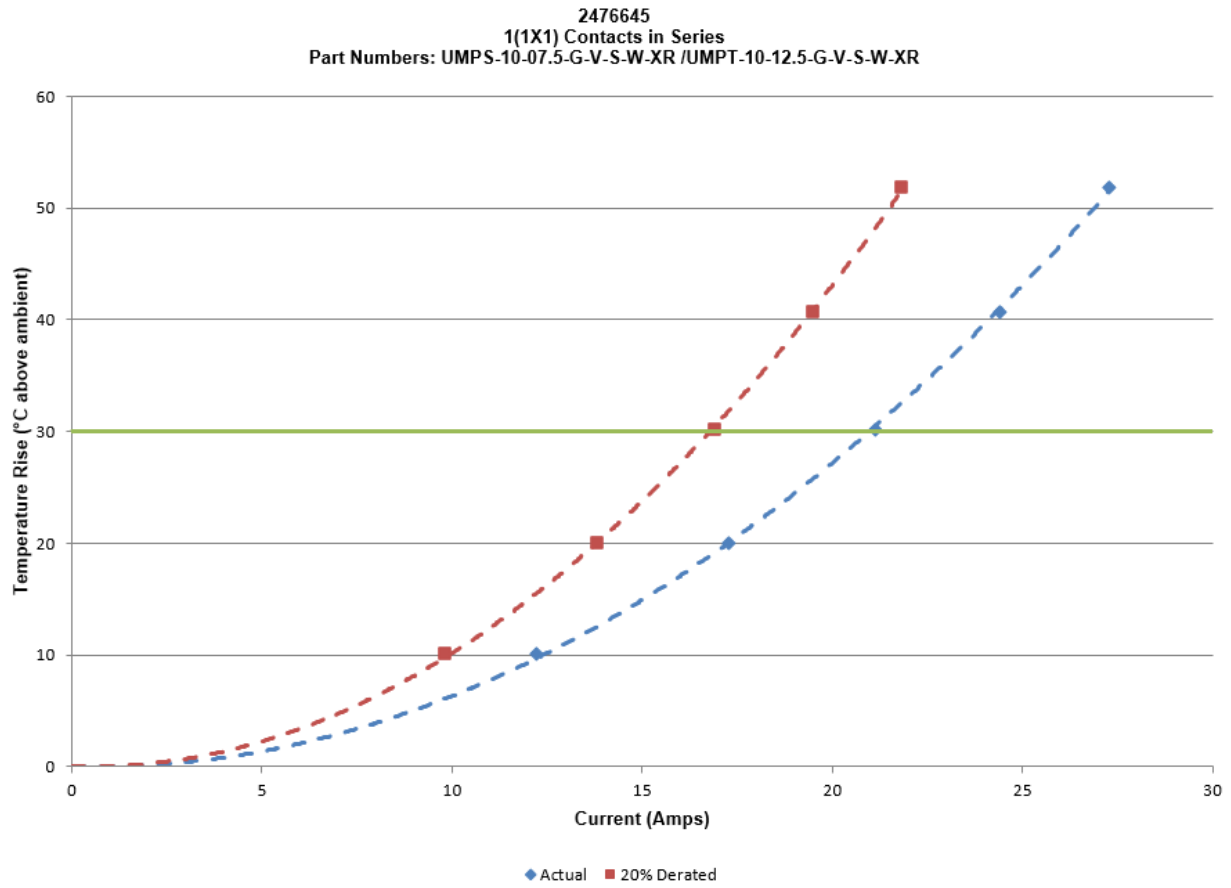
TEMPERATURE RISE (Current Carrying Capacity, CCC):

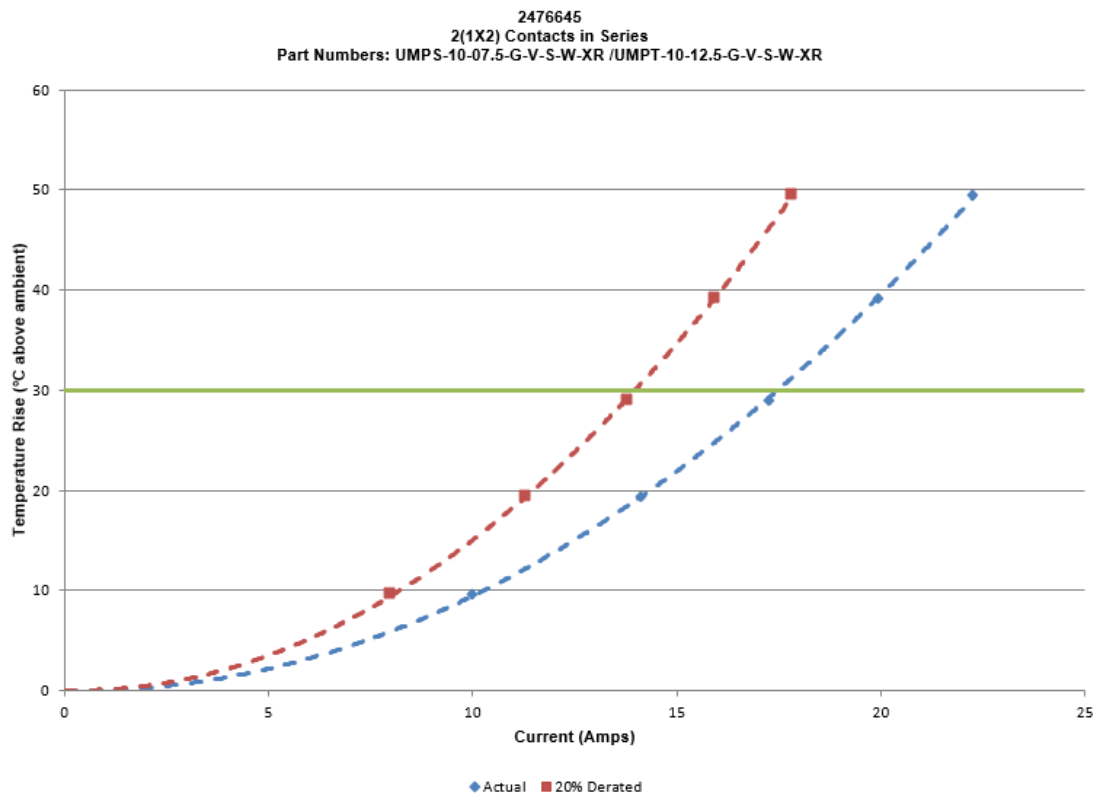
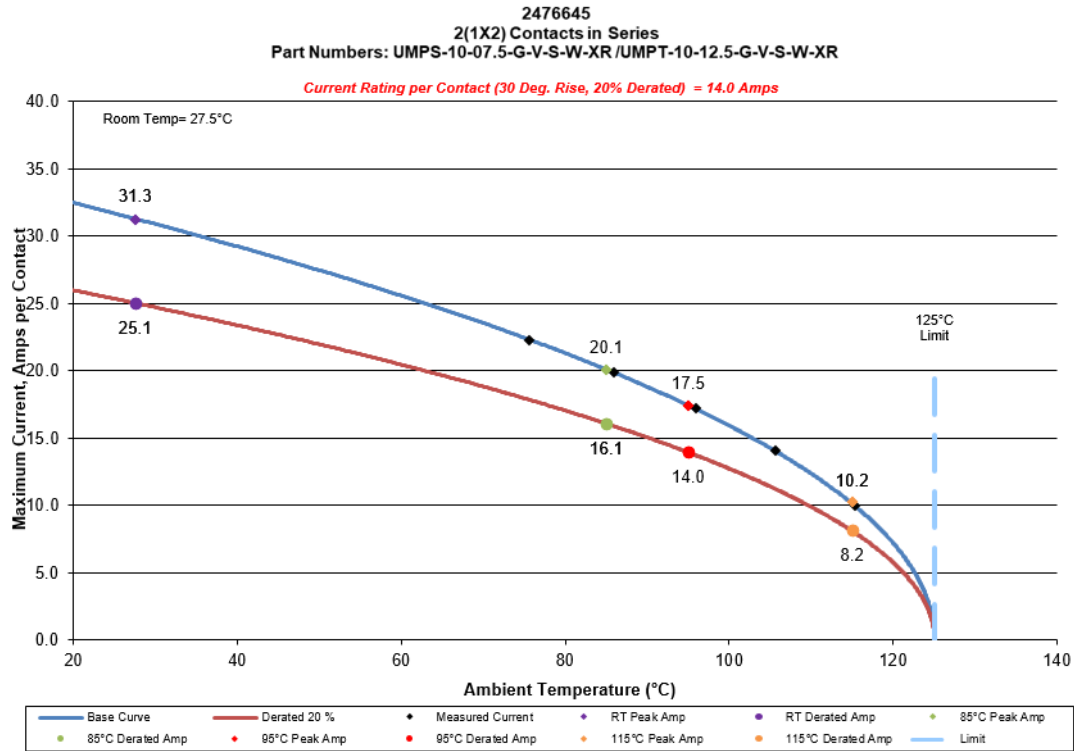
- 1) High quality thermocouples whose temperature slopes track one another were used for temperature monitoring.
- 2) The thermocouples were placed at a location to sense the maximum temperature generated during testing.
- 3) Temperature readings recorded are those for which three successive readings, 15 minutes apart, differ less than 1° C (computer-controlled data acquisition).
- 4) Adjacent contacts were powered:

UMPS-10-07.5-G-V-S-W-XR /UMPT-10-12.5-G-V-S-W-XR

- a. Linear configuration with 1 adjacent conductors/contacts powered

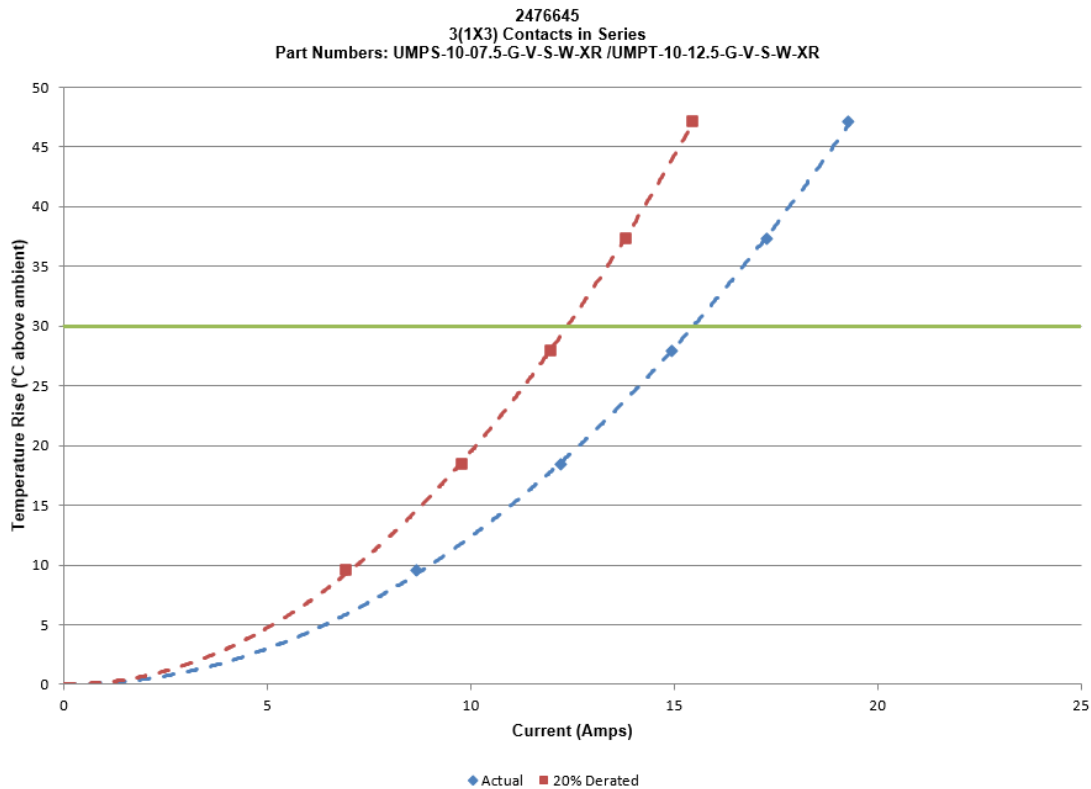
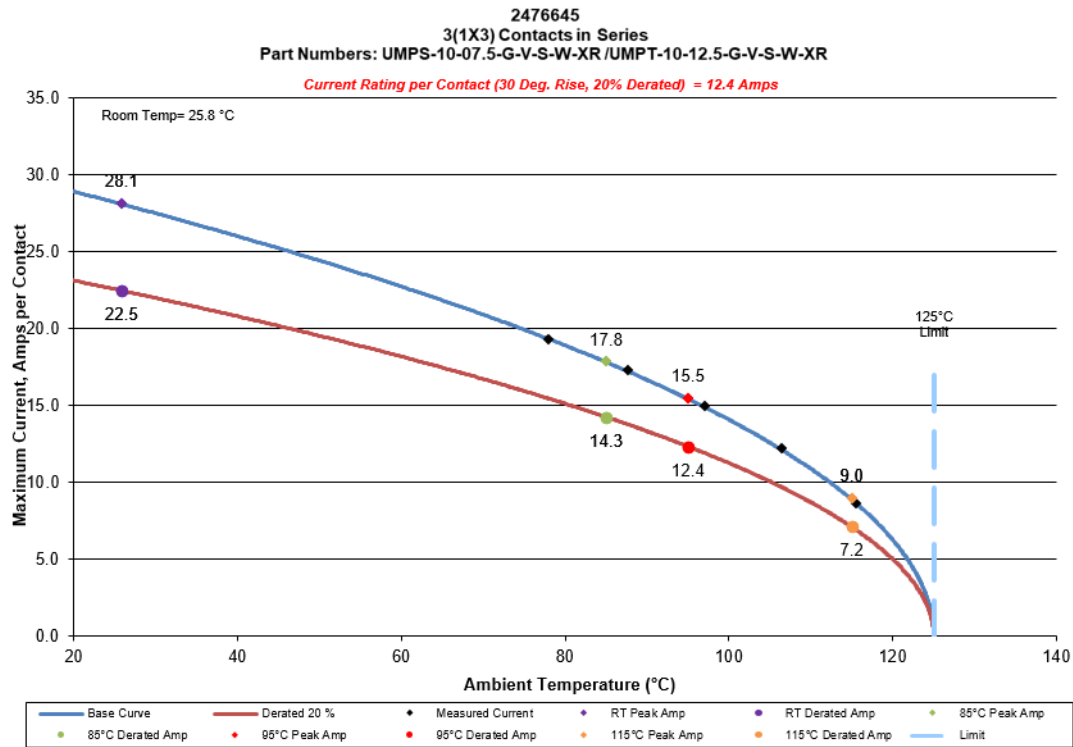


DATA SUMMARIES Continued

DATA SUMMARIES Continued**b. Linear configuration with 2 adjacent conductors/contacts powered**

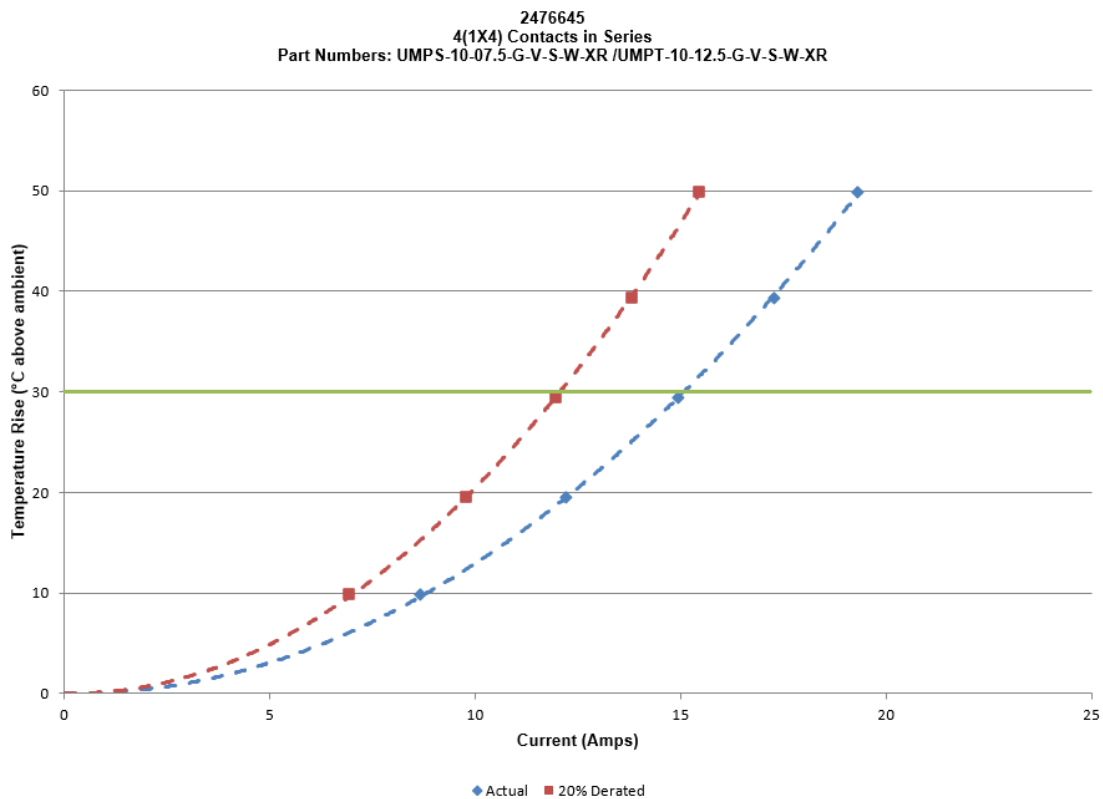
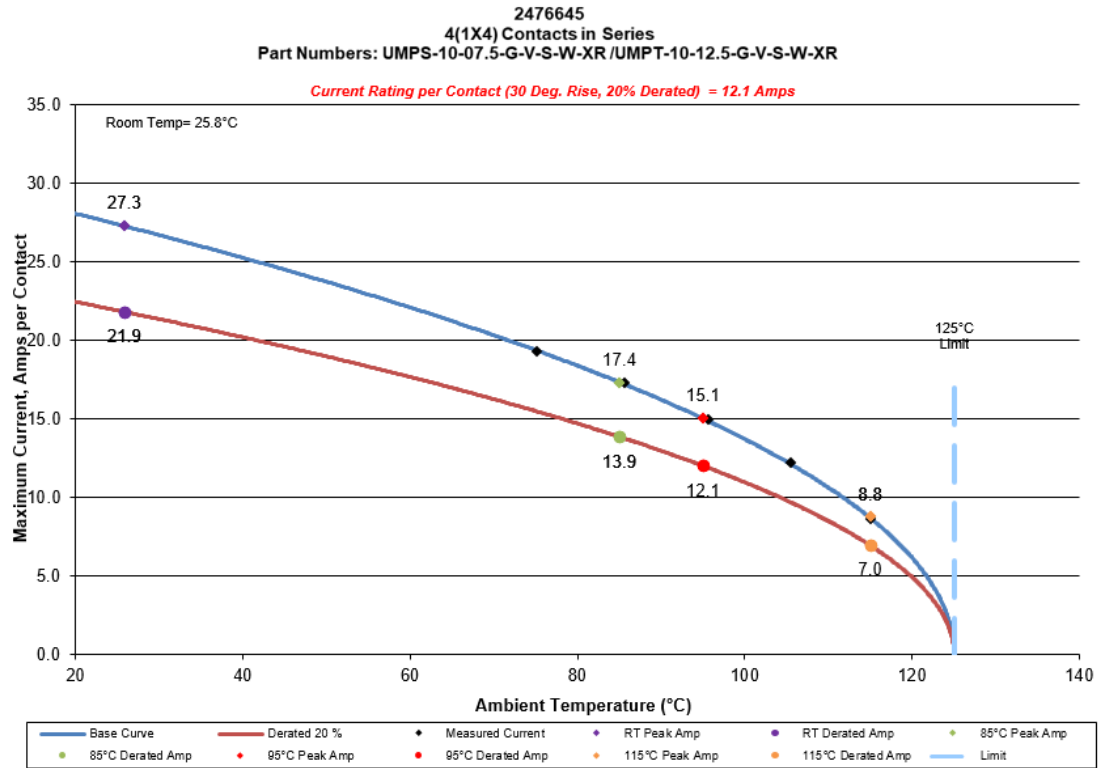
DATA SUMMARIES Continued

c. Linear configuration with 3 adjacent conductors/contacts powered



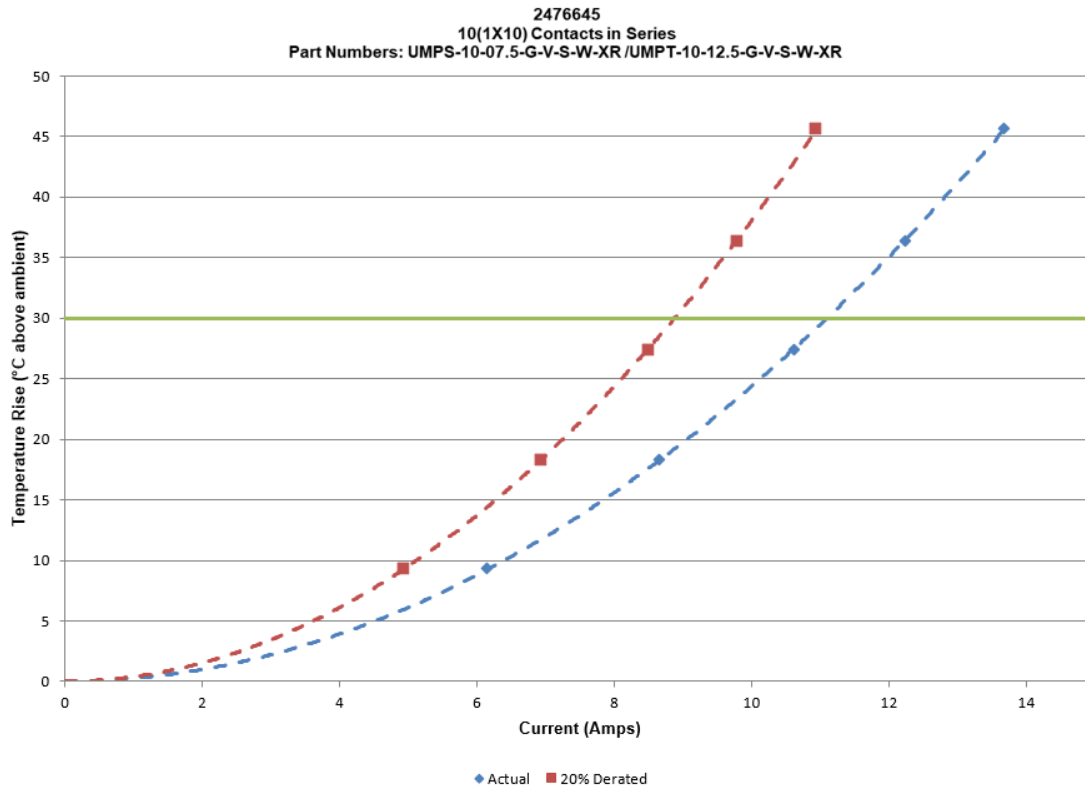
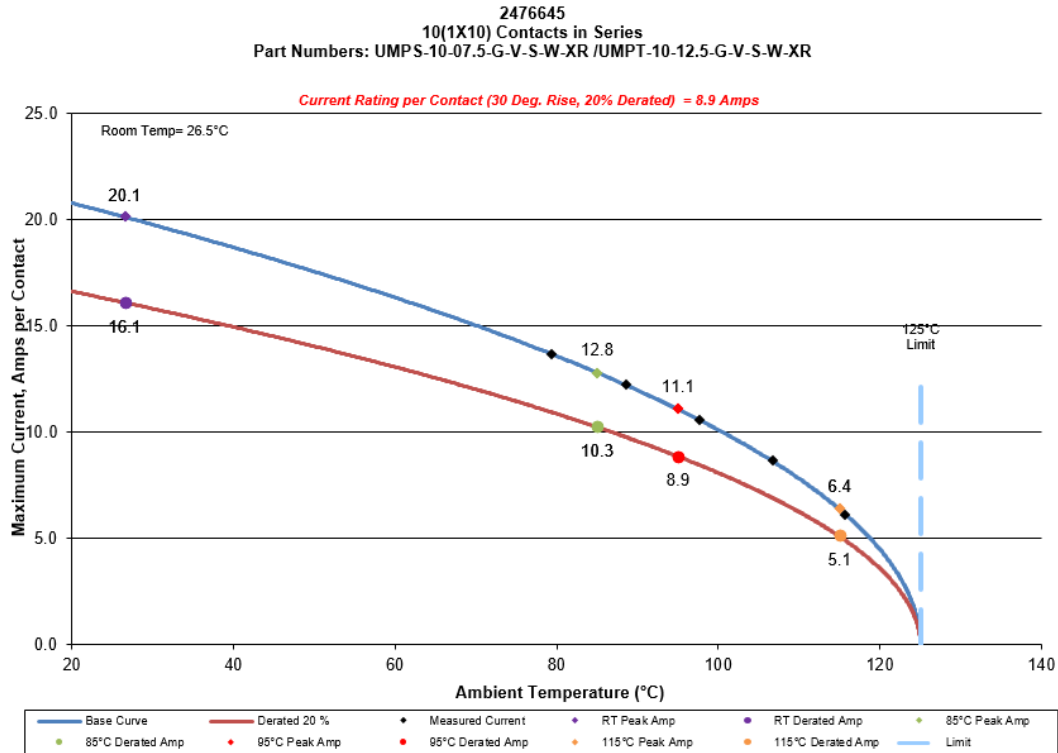
DATA SUMMARIES Continued

d. Linear configuration with 4 adjacent conductors/contacts powered



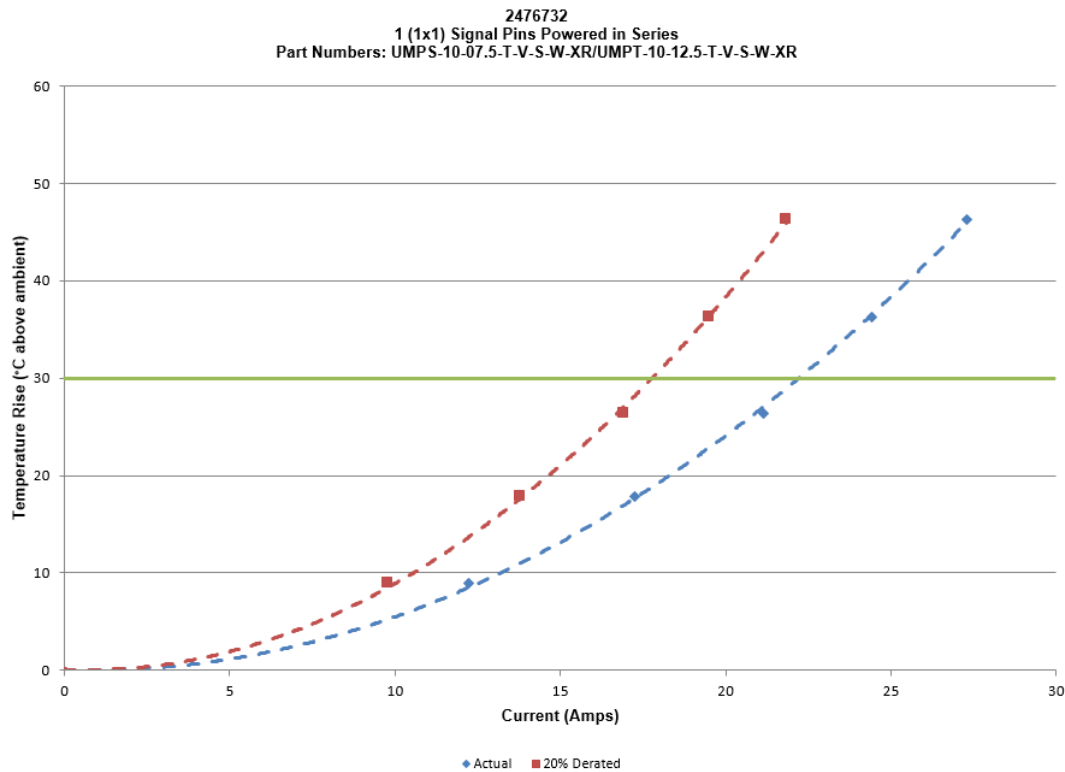
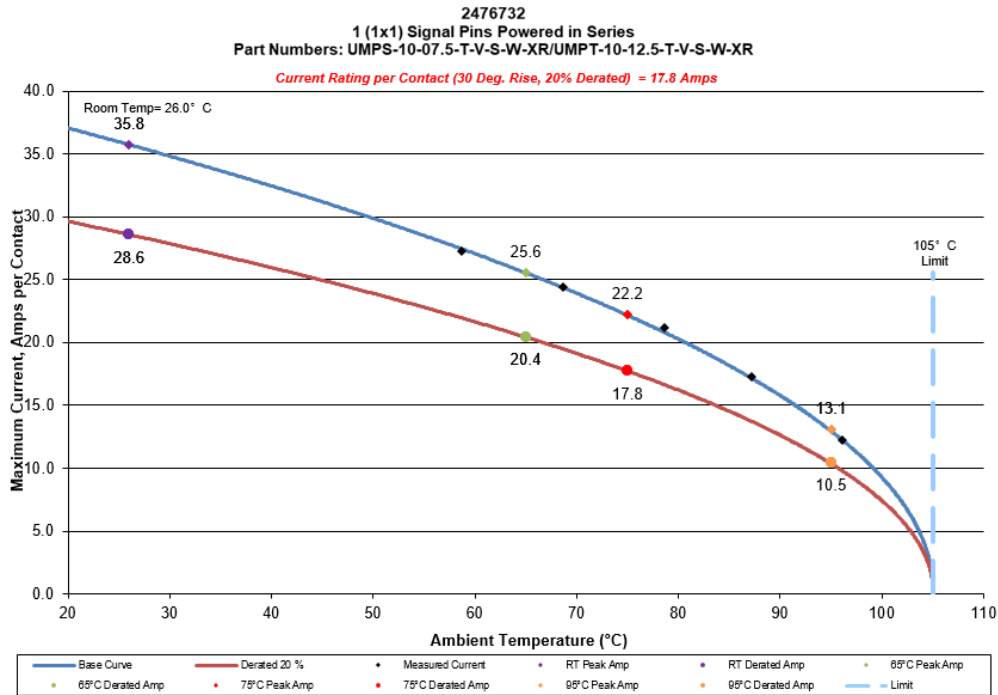
DATA SUMMARIES Continued

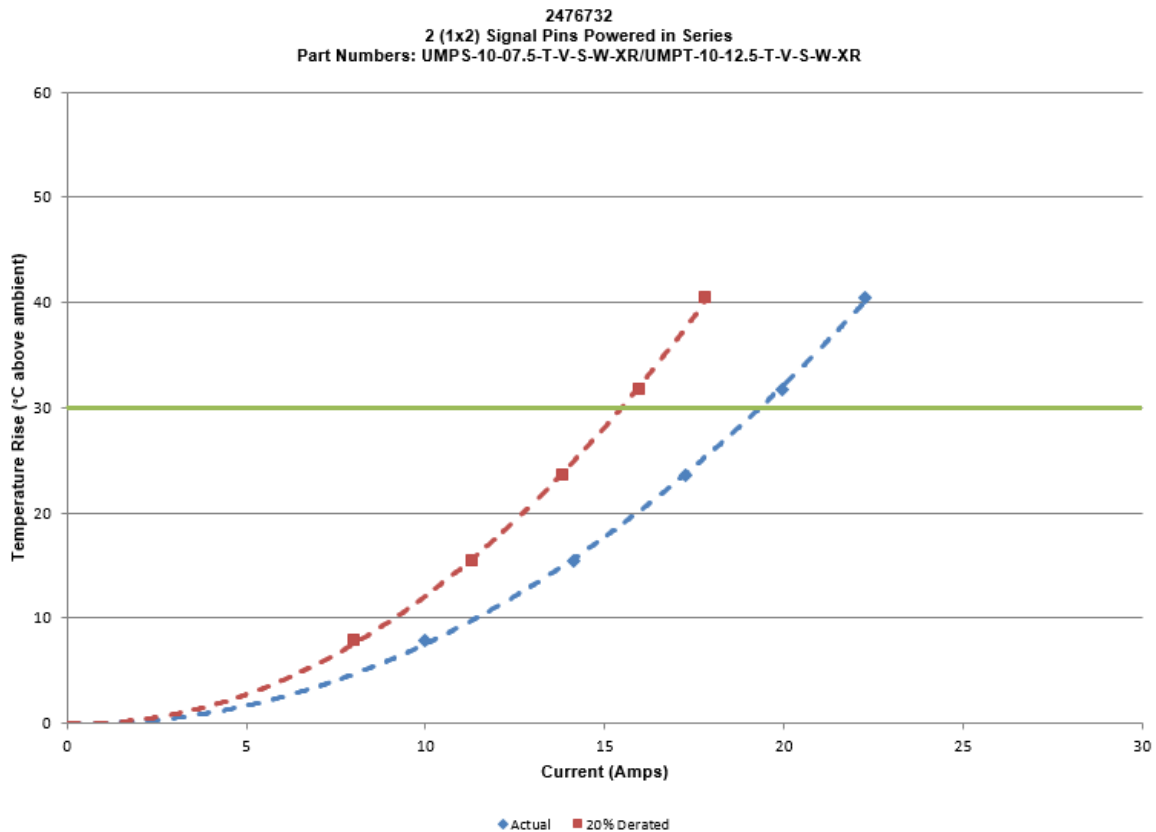
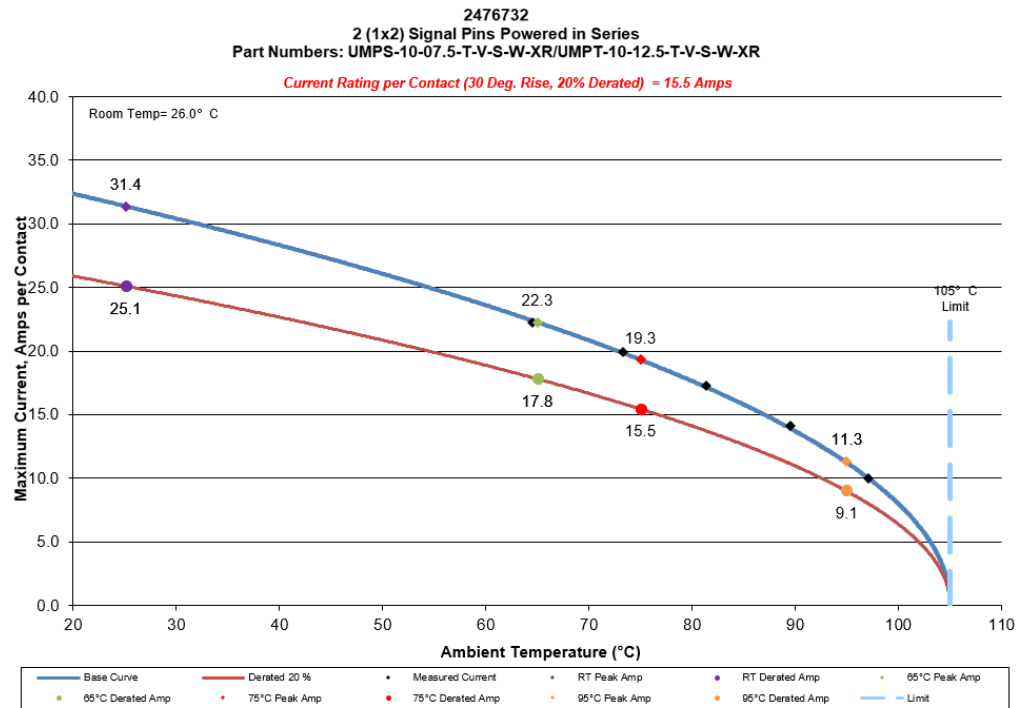
e. Linear configuration with all adjacent conductors/contacts powered



DATA SUMMARIES Continued**UMPS-10-07.5-T-V-S-W-XR /UMPT-10-12.5-T-V-S-W-XR**

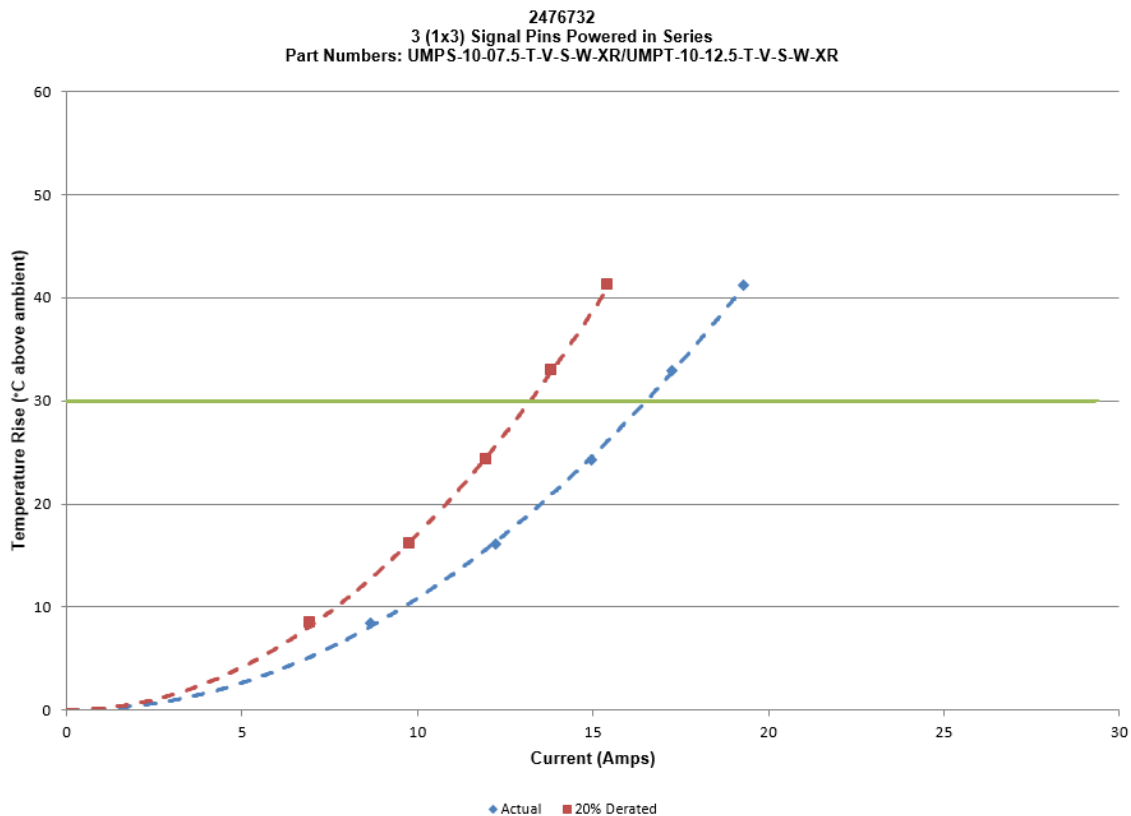
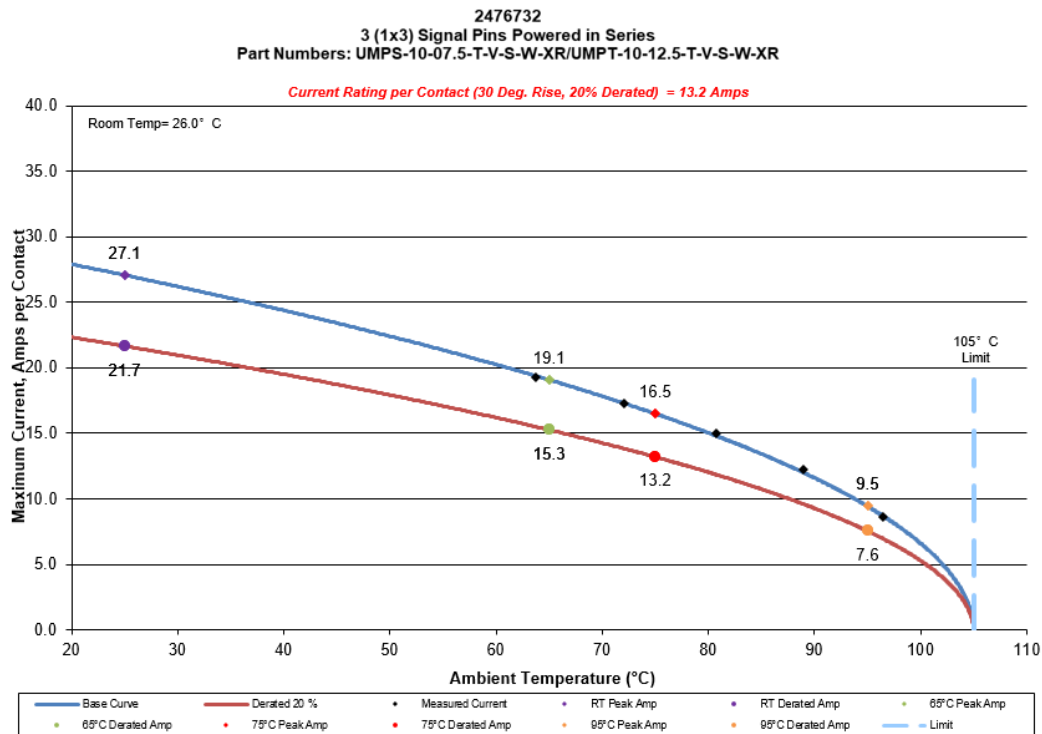
- a. Linear configuration with 1 adjacent conductors/contacts powered

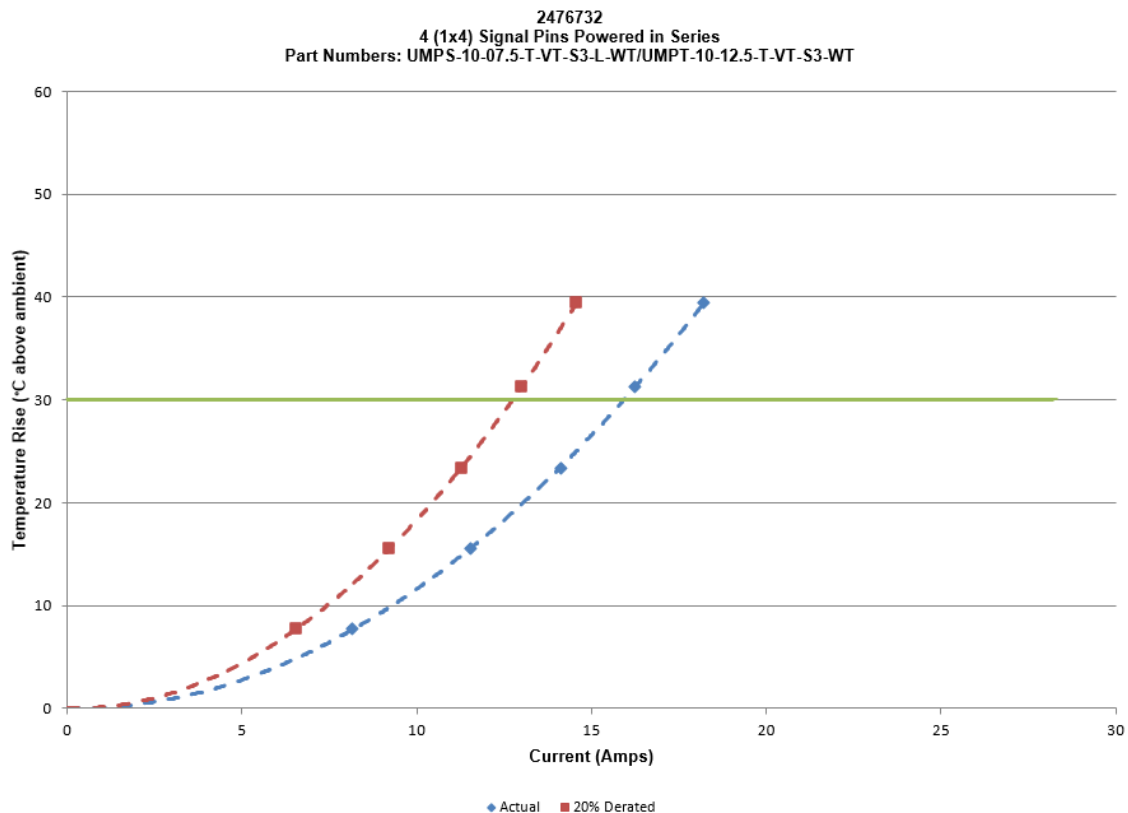
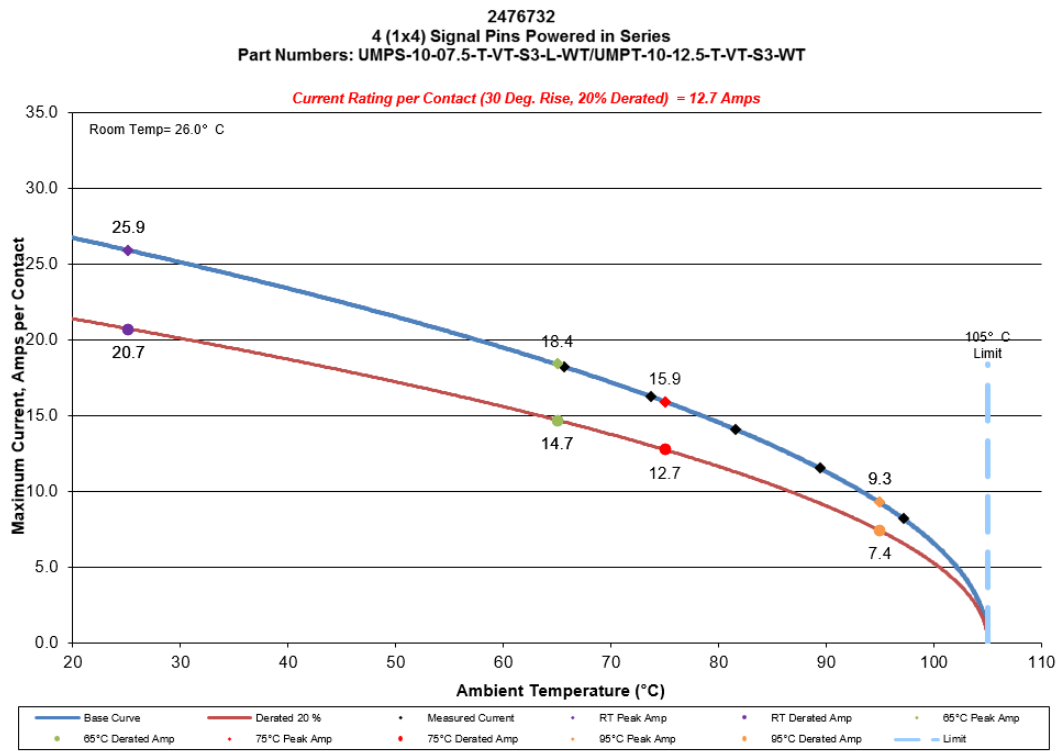


DATA SUMMARIES Continued**b. Linear configuration with 2 adjacent conductors/contacts powered**

DATA SUMMARIES Continued

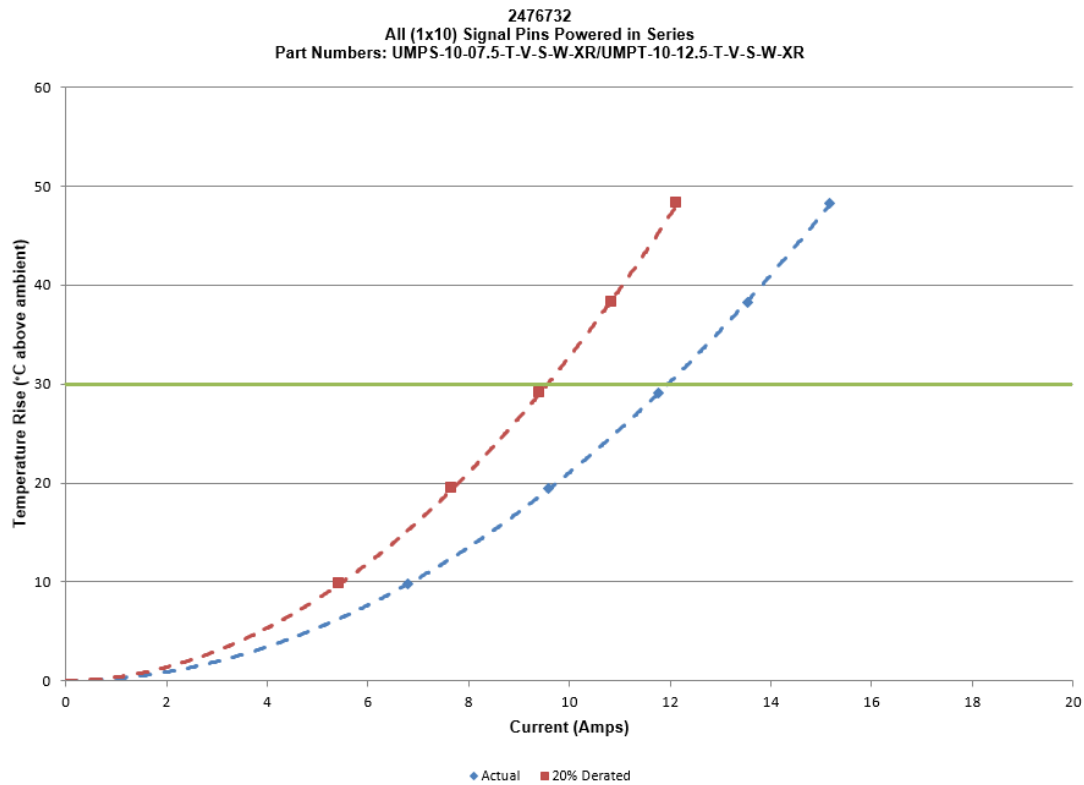
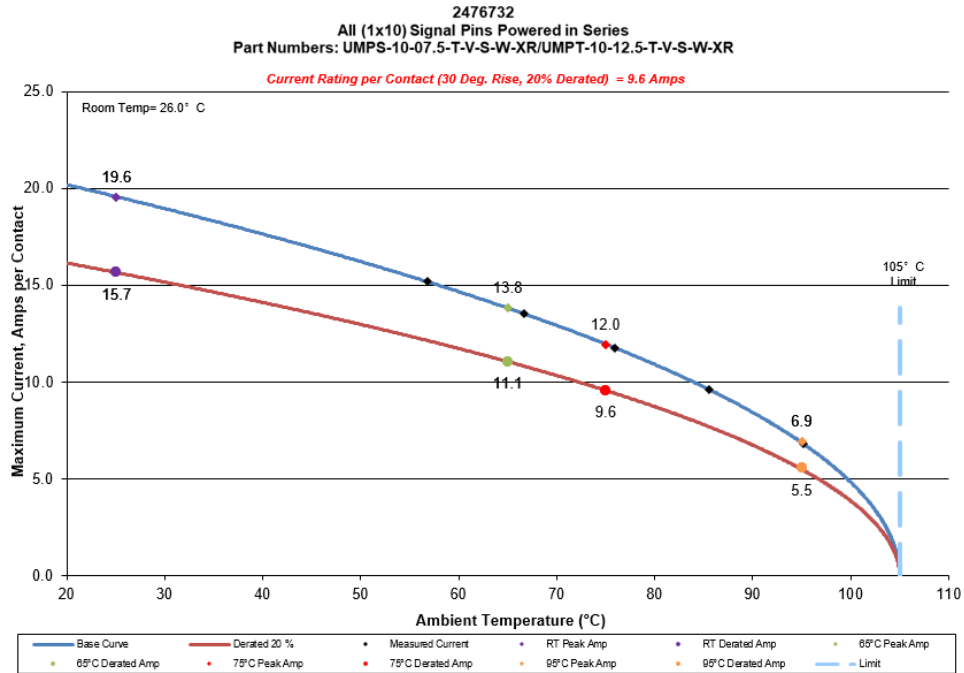
c. Linear configuration with 3 adjacent conductors/contacts powered



DATA SUMMARIES Continued**d. Linear configuration with 4 adjacent conductors/contacts powered**

DATA SUMMARIES Continued

e. Linear configuration with all adjacent conductors/contacts powered



DATA SUMMARIES Continued**MATING-UNMATING FORCE:****Thermal Aging Group (UMPS-06-07.5-G-V-S-W-XR/UMPT-06-02.5-G-V-S-W-XR)**

	Initial				After Thermals			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	27.31	6.14	12.90	2.90	11.43	2.57	7.43	1.67
Maximum	34.21	7.69	22.55	5.07	16.95	3.81	10.76	2.42
Average	29.96	6.74	17.26	3.88	13.06	2.94	8.70	1.96
St Dev	2.47	0.56	3.59	0.81	1.77	0.40	1.11	0.25
Count	8	8	8	8	8	8	8	8

Mating-Unmating Durability Group 1 (UMPS-06-07.5-G-V-S-W-XR/UMPT-06-02.5-G-V-S-W-XR)

	Initial				After 25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	24.86	5.59	13.48	3.03	26.29	5.91	17.75	3.99
Maximum	30.07	6.76	18.82	4.23	28.60	6.43	23.44	5.27
Average	27.86	6.26	15.71	3.53	27.52	6.19	20.39	4.58
St Dev	1.80	0.40	1.97	0.44	0.83	0.19	1.63	0.37
Count	8	8	8	8	8	8	8	8
	After 50 Cycles				After 75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	26.47	5.95	21.75	4.89	26.82	6.03	23.53	5.29
Maximum	28.38	6.38	25.35	5.70	28.60	6.43	27.00	6.07
Average	27.27	6.13	23.37	5.26	27.52	6.19	25.14	5.65
St Dev	0.71	0.16	1.18	0.27	0.54	0.12	1.08	0.24
Count	8	8	8	8	8	8	8	8
	After 100 Cycles				After Humidity			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	25.84	5.81	21.97	4.94	12.50	2.81	8.94	2.01
Maximum	29.05	6.53	28.02	6.30	14.37	3.23	10.41	2.34
Average	27.84	6.26	26.03	5.85	13.38	3.01	9.45	2.13
St Dev	1.00	0.23	1.86	0.42	0.66	0.15	0.53	0.12
Count	8	8	8	8	8	8	8	8

DATA SUMMARIES Continued**Mating-Unmating Durability Group 2 (UMPS-10-07.5-G-V-S-W-XR/UMPT-10-02.5-G-V-S-W-XR)**

	Initial				After 25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	46.66	10.49	22.73	5.11	54.89	12.34	31.36	7.05
Maximum	62.89	14.14	37.59	8.45	71.97	16.18	43.19	9.71
Average	58.32	13.11	33.49	7.53	68.01	15.29	39.91	8.97
St Dev	5.07	1.14	4.59	1.03	5.58	1.25	3.72	0.84
Count	8	8	8	8	8	8	8	8
	After 50 Cycles				After 75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	64.23	14.44	33.00	7.42	76.55	17.21	36.96	8.31
Maximum	85.31	19.18	49.28	11.08	86.74	19.50	52.31	11.76
Average	78.08	17.55	43.42	9.76	81.93	18.42	46.82	10.53
St Dev	6.59	1.48	4.87	1.09	2.87	0.64	4.94	1.11
Count	8	8	8	8	8	8	8	8
	After 100 Cycles				After Humidity			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	75.75	17.03	40.97	9.21	21.66	4.87	11.25	2.53
Maximum	90.34	20.31	49.64	11.16	23.71	5.33	16.32	3.67
Average	81.59	18.34	47.01	10.57	22.68	5.10	14.16	3.18
St Dev	4.33	0.97	2.67	0.60	0.61	0.14	1.57	0.35
Count	8	8	8	8	8	8	8	8

DATA SUMMARIES Continued**Mating-Unmating Durability Group 3 (UMPS-06-07.5-T-V-S-W-XR/UMPT-06-02.5-T-V-S-W-XR)**

	Initial				After 25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	32.07	7.21	27.67	6.22	32.43	7.29	24.42	5.49
Maximum	42.92	9.65	39.23	8.82	37.10	8.34	30.47	6.85
Average	37.86	8.51	33.05	7.43	34.81	7.83	27.14	6.10
St Dev	4.48	1.01	4.61	1.04	1.44	0.32	2.32	0.52
Count	8	8	8	8	8	8	8	8
	After 50 Cycles				After 75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	33.58	7.55	24.51	5.51	35.81	8.05	24.02	5.40
Maximum	37.81	8.50	30.69	6.90	40.48	9.10	30.07	6.76
Average	36.11	8.12	27.35	6.15	37.86	8.51	27.12	6.10
St Dev	1.53	0.34	2.36	0.53	1.60	0.36	2.11	0.47
Count	8	8	8	8	8	8	8	8
	After 100 Cycles				After Humidity			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	35.94	8.08	24.06	5.41	12.68	2.85	10.99	2.47
Maximum	42.21	9.49	31.09	6.99	16.64	3.74	11.92	2.68
Average	38.86	8.74	27.13	6.10	14.69	3.30	11.53	2.59
St Dev	2.07	0.47	2.27	0.51	1.66	0.37	0.35	0.08
Count	8	8	8	8	8	8	8	8

DATA SUMMARIES Continued**Mating-Unmating Durability Group 4 (UMPS-10-07.5-T-V-S-W-XR/UMPT-10-02.5-T-V-S-W-XR)**

	Initial				After 25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	60.89	13.69	54.93	12.35	58.49	13.15	41.77	9.39
Maximum	74.73	16.80	65.12	14.64	66.59	14.97	51.91	11.67
Average	66.95	15.05	60.07	13.51	64.17	14.43	45.54	10.24
St Dev	4.05	0.91	3.43	0.77	2.78	0.62	3.05	0.68
Count	8	8	8	8	8	8	8	8
	After 50 Cycles				After 75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	54.80	12.32	41.77	9.39	56.00	12.59	42.92	9.65
Maximum	61.56	13.84	45.50	10.23	61.29	13.78	45.10	10.14
Average	59.29	13.33	43.11	9.69	59.28	13.33	44.01	9.89
St Dev	2.11	0.48	1.16	0.26	1.58	0.35	0.87	0.20
Count	8	8	8	8	8	8	8	8
	After 100 Cycles				After Humidity			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	58.58	13.17	43.68	9.82	24.42	5.49	20.64	4.64
Maximum	62.58	14.07	47.19	10.61	29.00	6.52	22.91	5.15
Average	60.79	13.67	45.01	10.12	26.59	5.98	21.97	4.94
St Dev	1.36	0.31	1.26	0.28	1.34	0.30	0.92	0.21
Count	8	8	8	8	8	8	8	8

DATA SUMMARIES Continued**INSULATION RESISTANCE (IR):**

	Pin to Pin		
	Mated	Unmated	Unmated
Minimum	UMPS/UMPT	UMPS	UMPT
Initial	45000	45000	45000
Thermal	45000	45000	45000
Humidity	45000	45000	45000

	Pin to Closest Metallic Hardware		
	Mated	Unmated	Unmated
Minimum	UMPS/UMPT	UMPS	UMPT
Initial	45000	45000	45000
Thermal	45000	45000	45000
Humidity	45000	45000	45000

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

Voltage Rating Summary	
Minimum	UMPS/UMPT
Break Down Voltage	1685
Test Voltage	1265
Working Voltage	420

Pin to Pin	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

Pin to Closest Metallic Hardware	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

DATA SUMMARIES Continued**LLCR Thermal Aging Group**

- 1) A total of 48 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +0.33$ mOhms: -----Stable
 - b. $+0.34$ to $+0.66$ mOhms: -----Minor
 - c. $+0.67$ to $+1.00$ mOhms: -----Acceptable
 - d. $+1.01$ to $+50.0$ mOhms: -----Marginal
 - e. $+50.1$ to $+1000$ mOhms:-----Unstable
 - f. $>+1000$ mOhms:-----Open Failure

UMPS-06-07.5-G-V-S-W-XR/UMPT-06-02.5-G-V-S-W-XR

LLCR Measurement Summaries by Pin Type				
Date	7/23/2020	8/4/2020		
Room Temp (Deg C)	22	22		
Rel Humidity (%)	52	52		
Technician	Kason He	Kason He		
mOhm values	Actual Initial	Delta Thermal	Delta	Delta
Pin Type 1: Signal				
Average	0.87	0.08		
St. Dev.	0.08	0.09		
Min	0.70	0.01		
Max	1.05	0.57		
Summary Count	48	48		
Total Count	48	48		

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 0.33	$>0.34 \text{ \& } \leq 0.66$	$>0.67 \text{ \& } \leq 1.00$	$>1.01 \text{ \& } \leq 50$	$>50 \text{ \& } \leq 1000$	>1000
Thermal	47	1	0	0	0	0

DATA SUMMARIES Continued**LLCR Mating/Unmating Durability Group**

- 1). A total of 48 points were measured.
- 2). EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3). A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4). The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +0.33$ mOhms: -----Stable
 - b. $+0.34$ to $+0.66$ mOhms: -----Minor
 - c. $+0.67$ to $+1.00$ mOhms: -----Acceptable
 - d. $+1.01$ to $+50.0$ mOhms: -----Marginal
 - e. $+50.1$ to $+1000$ mOhms:-----Unstable
 - f. $>+1000$ mOhms:-----Open Failure

Group 1 (UMPS-06-07.5-G-V-S-W-XR/UMPT-06-02.5-G-V-S-W-XR)

LLCR Measurement Summaries by Pin Type				
Date	7/21/2020	7/23/2020	7/29/2020	8/11/2020
Room Temp (Deg C)	22	22	22	22
Rel Humidity (%)	52	52	52	52
Technician	Kason He	Kason He	Kason He	Kason He
mOhm values	Actual Initial	Delta 100 Cycles	Delta Therm Shck	Delta Humidity
Pin Type 1: Signal				
Average	0.89	0.02	0.02	0.24
St. Dev.	0.08	0.01	0.01	0.23
Min	0.71	0.00	0.00	0.01
Max	1.05	0.05	0.07	0.99
Summary Count	48	48	48	48
Total Count	48	48	48	48

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 0.33	$>0.34 \text{ \& } \leq 0.66$	$>0.67 \text{ \& } \leq 1.00$	$>1.01 \text{ \& } \leq 50$	$>50 \text{ \& } \leq 1000$	>1000
100 Cycles	48	0	0	0	0	0
Therm Shck	48	0	0	0	0	0
Humidity	38	7	3	0	0	0

DATA SUMMARIES Continued**LLCR Mating/Unmating Durability Group**

- 1). A total of 80 points were measured.
- 2). EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3). A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4). The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +0.33$ mOhms: -----Stable
 - b. $+0.34$ to $+0.66$ mOhms: -----Minor
 - c. $+0.67$ to $+1.00$ mOhms: -----Acceptable
 - d. $+1.01$ to $+50.0$ mOhms: -----Marginal
 - e. $+50.1$ to $+1000$ mOhms:-----Unstable
 - f. $>+1000$ mOhms:-----Open Failure

Group 2 (UMPS-10-07.5-G-V-S-W-XR/UMPT-10-02.5-G-V-S-W-XR)

LLCR Measurement Summaries by Pin Type				
Date	7/21/2020	7/23/2020	7/29/2020	8/11/2020
Room Temp (Deg C)	22	22	22	22
Rel Humidity (%)	52	52	52	52
Technician	Kason He	Kason He	Kason He	Kason He
mOhm values	Actual Initial	Delta 100 Cycles	Delta Therm Shck	Delta Humidity
Pin Type 1: Signal				
Average	0.82	0.03	0.05	0.35
St. Dev.	0.06	0.02	0.03	0.28
Min	0.64	0.00	0.00	0.04
Max	0.97	0.08	0.11	1.38
Summary Count	80	80	80	80
Total Count	80	80	80	80

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 0.33	$>0.34 \text{ \& } \leq 0.66$	$>0.67 \text{ \& } \leq 1.00$	$>1.01 \text{ \& } \leq 50$	$>50 \text{ \& } \leq 1000$	>1000
100 Cycles	80	0	0	0	0	0
Therm Shck	80	0	0	0	0	0
Humidity	53	20	4	3	0	0

DATA SUMMARIES Continued**LLCR Mating/Unmating Durability Group**

- 1). A total of 48 points were measured.
- 2). EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3). A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4). The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +0.33$ mOhms: -----Stable
 - b. $+0.34$ to $+0.66$ mOhms: -----Minor
 - c. $+0.67$ to $+1.00$ mOhms: -----Acceptable
 - d. $+1.01$ to $+50.0$ mOhms: -----Marginal
 - e. $+50.1$ to $+1000$ mOhms:-----Unstable
 - f. $>+1000$ mOhms:-----Open Failure

Group 3 (UMPS-06-07.5-T-V-S-W-XR/UMPT-06-02.5-T-V-S-W-XR)

LLCR Measurement Summaries by Pin Type				
Date	7/21/2020	7/24/2020	7/29/2020	8/10/2020
Room Temp (Deg C)	23	23	23	23
Rel Humidity (%)	54	54	54	54
Technician	Peter Chen	Peter Chen	Peter Chen	Peter Chen
mOhm values	Actual Initial	Delta 100 Cycles	Delta Therm Shck	Delta Humidity
Pin Type 1: Signal				
Average	0.82	0.21	0.22	0.65
St. Dev.	0.08	0.11	0.17	0.24
Min	0.62	0.04	0.00	0.23
Max	0.99	0.45	0.63	1.20
Summary Count	48	48	48	48
Total Count	48	48	48	48

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 0.33	>0.34 & ≤ 0.66	>0.67 & ≤ 1.00	>1.01 & ≤ 50	>50 & ≤ 1000	>1000
100 Cycles	42	6	0	0	0	0
Therm Shck	36	12	0	0	0	0
Humidity	7	19	19	3	0	0

DATA SUMMARIES Continued**LLCR Mating/Unmating Durability Group**

- 1). A total of 80 points were measured.
- 2). EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3). A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4). The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +0.33$ mOhms: -----Stable
 - b. $+0.34$ to $+0.66$ mOhms: -----Minor
 - c. $+0.67$ to $+1.00$ mOhms: -----Acceptable
 - d. $+1.01$ to $+50.0$ mOhms: -----Marginal
 - e. $+50.1$ to $+1000$ mOhms:-----Unstable
 - f. $>+1000$ mOhms:-----Open Failure

Group 4 (UMPS-10-07.5-T-V-S-W-XR/UMPT-10-02.5-T-V-S-W-XR)

LLCR Measurement Summaries by Pin Type				
Date	7/21/2020	7/24/2020	7/29/2020	8/10/2020
Room Temp (Deg C)	23	23	23	23
Rel Humidity (%)	54	54	54	54
Technician	Peter Chen	Peter Chen	Peter Chen	Peter Chen
mOhm values	Actual Initial	Delta 100 Cycles	Delta Therm Shck	Delta Humidity
Pin Type 1: Signal				
Average	0.73	0.15	0.34	0.45
St. Dev.	0.06	0.09	0.19	0.28
Min	0.57	0.03	0.08	0.08
Max	0.90	0.40	0.87	1.26
Summary Count	80	80	80	80
Total Count	80	80	80	80

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 0.33	>0.34 & ≤ 0.66	>0.67 & ≤ 1.00	>1.01 & ≤ 50	>50 & ≤ 1000	>1000
100 Cycles	77	3	0	0	0	0
Therm Shck	48	25	7	0	0	0
Humidity	34	28	16	2	0	0

EQUIPMENT AND CALIBRATION SCHEDULES**Equipment #:** HZ-TCT-01**Description:** Normal force analyzer**Manufacturer:** Mecmesin Multitester**Model:** Mecmesin Multitester 2.5-i**Serial #:** 08-1049-04**Accuracy:** Last Cal: 3/5/2020, Next Cal: 3/4/2021**Equipment #:** DG-THC-01**Description:** Humidity transmitter**Manufacturer:** Thermtron**Model:** SM-8-8200**Serial #:** 50613**Accuracy:** Last Cal: 12/4/2019, Next Cal: 12/3/2020**Equipment #:** HZ-TSC-01**Description:** Vertical Thermal Shock Chamber**Manufacturer:** Cincinnatti Sub Zero**Model:** VTS-3-6-6-SC/AC**Serial #:** 10-VT14994**Accuracy:** See Manual

... Last Cal: 04/16/2020, Next Cal: 04/15/2021

Equipment #: HZ-OV-01**Description:** Oven**Manufacturer:** Huida**Model:** CS101-1E**Serial #:** CS101-1E-B**Accuracy:** Last Cal: 12/11/2019, Next Cal: 12/11/2020**Equipment #:** DG-HPT-01**Description:** Hipot Safety Tester**Manufacturer:** Vitrek**Model:** V73**Serial #:** 025866**Accuracy:**

... Last Cal: 04/16/2020, Next Cal: 04/15/2021

Equipment #: HZ-MO-05**Description:** Micro-ohmmeter**Manufacturer:** Keithley**Model:** 3706**Serial #:** 1285188**Accuracy:** Last Cal: 1/2/2020, Next Cal: 1/1/2021**Equipment #:** HZ-MO-01**Description:** Micro-ohmmeter**Manufacturer:** Keithley**Model:** 2700**Serial #:** 1199807**Accuracy:** Last Cal: 05/19/2020, Next Cal: 05/18/2021

EQUIPMENT AND CALIBRATION SCHEDULES Continued**Equipment #:** HZ-PS-01**Description:** Power Supply**Manufacturer:** Agilent**Model:** 6031A**Serial #:** MY41000982**Accuracy:** Last Cal: 04/16/2020, Next Cal: 04/15/2021**Equipment #:** ACLM-01**Description:** Accelerometer**Manufacturer:** PCB Piezotronics**Model:** 352C03**Serial #:** 115819**Accuracy:** See Manual

... Last Cal: 07/18/2020, Next Cal: 07/18/2021

Equipment #: ED-03**Description:** Event Detector**Manufacturer:** Analysis Tech**Model:** 32EHD**Serial #:** 1100604**Accuracy:** See Manual

... Last Cal: 10/31/2019, Next Cal: 10/31/2020